





RADIO TEST REPORT

Test Report No. 15192509H-B-R2

Customer	Murata Manufacturing Co., Ltd.
Description of EUT	Communication Module
Model Number of EUT	2FJ
FCC ID	VPYLB2FJ1
Test Regulation	FCC Part 15 Subpart C
Test Result	Complied
Issue Date	May 28, 2024
Remarks	Bluetooth (BR / EDR) parts

Representative Test Engineer	Approved By
	
Shousei Hamaguchi Engineer	Takumi Shimada Engineer
	 
	CERTIFICATE 5107.02
<input type="checkbox"/> The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan, Inc.	
<input checked="" type="checkbox"/> There is no testing item of "Non-accreditation".	

Report Cover Page - Form-ULID-003532 (DCS:13-EM-F0429) Issue# 23.0

ANNOUNCEMENT

- This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
- The results in this report apply only to the sample tested. (Laboratory was not involved in sampling.)
- This sample tested is in compliance with the limits of the above regulation.
- The test results in this test report are traceable to the national or international standards.
- This test report must not be used by the customer to claim product certification, approval, or endorsement by the A2LA accreditation body.
- This test report covers Radio technical requirements.
It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
- The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
- The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan, Inc. has been accredited.
- The information provided by the customer for this report is identified in SECTION 1.
- The laboratory is not responsible for information provided by the customer which can impact the validity of the results.
- For test report(s) referred in this report, the latest version (including any revisions) is always referred.

REVISION HISTORY

Original Test Report No.: 15192509H-B

This report is a revised version of 15192509H-B-R1. 15192509H-B-R1 is replaced with this report.

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	15192509H-B	May 20, 2024	-
1	15192509H-B-R1	May 27, 2024	Section 3.2 FCC Part 15.31 (e) -Correction of sentence. This EUT provides the stable voltage constantly to RF Module regardless of input voltage.→ The stable voltage was provided to the EUT during the tests. FCC Part 15.203/212 Antenna requirement -Correction of sentence. It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. → The antenna is not removable from the EUT.
1	15192509H-B-R1	May 27, 2024	Appendix 1: Test data (P33, 38) Correction of frequency (and relevant value). 7320 MHz→ 7323 MHz 9760 MHz→9764 MHz
2	15192509H-B-R2	May 28, 2024	Section 3.2 FCC Part 15.31 (e) -Correction of sentence. The stable voltage was provided to the EUT during the tests. → The RF Module has its own regulator. The RF Module is constantly provided voltage through the regulator regardless of input voltage.

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	ICES	Interference-Causing Equipment Standard
AC	Alternating Current	IEC	International Electrotechnical Commission
AFH	Adaptive Frequency Hopping	IEEE	Institute of Electrical and Electronics Engineers
AM	Amplitude Modulation	IF	Intermediate Frequency
Amp, AMP	Amplifier	ILAC	International Laboratory Accreditation Conference
ANSI	American National Standards Institute	ISED	Innovation, Science and Economic Development Canada
Ant, ANT	Antenna	ISO	International Organization for Standardization
AP	Access Point	JAB	Japan Accreditation Board
ASK	Amplitude Shift Keying	LAN	Local Area Network
Atten., ATT	Attenuator	LIMS	Laboratory Information Management System
AV	Average	MCS	Modulation and Coding Scheme
BPSK	Binary Phase-Shift Keying	MRA	Mutual Recognition Arrangement
BR	Bluetooth Basic Rate	N/A	Not Applicable
BT	Bluetooth	NIST	National Institute of Standards and Technology
BT LE	Bluetooth Low Energy	NS	No signal detect.
BW	BandWidth	NSA	Normalized Site Attenuation
Cal Int	Calibration Interval	NVLAP	National Voluntary Laboratory Accreditation Program
CCK	Complementary Code Keying	OBW	Occupied Band Width
Ch., CH	Channel	OFDM	Orthogonal Frequency Division Multiplexing
CISPR	Comite International Special des Perturbations Radioelectriques	P/M	Power meter
CW	Continuous Wave	PCB	Printed Circuit Board
DBPSK	Differential BPSK	PER	Packet Error Rate
DC	Direct Current	PHY	Physical Layer
D-factor	Distance factor	PK	Peak
DFS	Dynamic Frequency Selection	PN	Pseudo random Noise
DQPSK	Differential QPSK	PRBS	Pseudo-Random Bit Sequence
DSSS	Direct Sequence Spread Spectrum	PSD	Power Spectral Density
EDR	Enhanced Data Rate	QAM	Quadrature Amplitude Modulation
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	QP	Quasi-Peak
EMC	ElectroMagnetic Compatibility	QPSK	Quadri-Phase Shift Keying
EMI	ElectroMagnetic Interference	RBW	Resolution Band Width
EN	European Norm	RDS	Radio Data System
ERP, e.r.p.	Effective Radiated Power	RE	Radio Equipment
EU	European Union	RF	Radio Frequency
EUT	Equipment Under Test	RMS	Root Mean Square
Fac.	Factor	RSS	Radio Standards Specifications
FCC	Federal Communications Commission	Rx	Receiving
FHSS	Frequency Hopping Spread Spectrum	SA, S/A	Spectrum Analyzer
FM	Frequency Modulation	SG	Signal Generator
Freq.	Frequency	SVSWR	Site-Voltage Standing Wave Ratio
FSK	Frequency Shift Keying	TR	Test Receiver
GFSK	Gaussian Frequency-Shift Keying	Tx	Transmitting
GNSS	Global Navigation Satellite System	VBW	Video BandWidth
GPS	Global Positioning System	Vert.	Vertical
Hori.	Horizontal	WLAN	Wireless LAN

CONTENTS	PAGE
SECTION 1: Customer Information	5
SECTION 2: Equipment Under Test (EUT)	5
SECTION 3: Test Specification, Procedures & Results	7
SECTION 4: Operation of EUT during testing	10
SECTION 5: Conducted Emission	14
SECTION 6: Radiated Spurious Emission	15
SECTION 7: Antenna Terminal Conducted Tests	17
APPENDIX 1: Test data	18
Conducted Emission	18
20dB Bandwidth, 99%Occupied Bandwidth and Carrier Frequency Separation	19
Number of Hopping Frequency.....	23
Dwell time	25
Maximum Peak Output Power	28
Average Output Power.....	29
Radiated Spurious Emission.....	31
Conducted Spurious Emission.....	42
Conducted Emission Band Edge compliance	48
APPENDIX 2: Test Instruments	50
APPENDIX 3: Photographs of test setup	52
Conducted Emission	52
Radiated Spurious Emission.....	53
Worst Case Position	54
Antenna Terminal Conducted Tests	55

SECTION 1: Customer Information

Company Name	Murata Manufacturing Co., Ltd.
Address	1-10-1 Higashikotari, Nagaokakyo-shi, Kyoto 617-8555 Japan
Telephone Number	+81-50-1737-2801
Contact Person	Kenji Hayashikoshi

The information provided by the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

SECTION 2: Equipment Under Test (EUT)

2.1 Identification of EUT

Description	Communication Module
Model Number	2FJ
Serial Number	Refer to SECTION 4.2
Condition	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	No Modification by the test lab
Receipt Date	March 29, 2024
Test Date	April 2 to 24, 2024

2.2 Product Description

General Specification

Rating	Typ: DC 3.3 V / Min: DC 3.0 V / Max: DC 3.6 V
Operating temperature	-30 deg. C to 70 deg. C

Radio Specification

This report contains data provided by the customer which can impact the validity of results. UL Japan, Inc. is only responsible for the validity of results after the integration of the data provided by the customer. The data provided by the customer is marked "a)" in the table below.

WLAN (IEEE802.11b/11g/11n-20)

Equipment Type	Transceiver
Frequency of Operation	2412 MHz to 2462 MHz
Type of Modulation	DSSS, OFDM
Antenna Gain ^{a)}	1.33 dBi

Bluetooth (BR/EDR/Low Energy)

Equipment Type	Transceiver
Frequency of Operation	2402 MHz to 2480 MHz
Type of Modulation	BT: FHSS (GFSK, $\pi/4$ DQPSK, 8 DPSK) BT LE: GFSK
Antenna Gain ^{a)}	1.33 dBi

* WLAN and Bluetooth do not transmit simultaneously.

SECTION 3: Test Specification, Procedures & Results

3.1 Test Specification

Test Specification	FCC Part 15 Subpart C The latest version on the first day of the testing period
Title	FCC 47 CFR Part 15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits Section 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz

3.2 Procedures and Results

Item	Test Procedure	Specification	Worst Margin	Results	Remarks	
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods ISED: RSS-Gen 8.8	FCC: Section 15.207 ISED: RSS-Gen 8.8	31.37 dB, 0.15000 MHz, QP, L	Complied	-	
Carrier Frequency Separation	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section15.247(a)(1) ISED: RSS-247 5.1 (b)	See data.	Complied	Conducted	
20dB Bandwidth	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section15.247(a)(1) ISED: RSS-247 5.1 (a)		Complied	Conducted	
Number of Hopping Frequency	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section15.247(a)(1)(iii) ISED: RSS-247 5.1 (d)		Complied	Conducted	
Dwell time	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section15.247(a)(1)(iii) ISED: RSS-247 5.1 (d)		Complied	Conducted	
Maximum Peak Output Power	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.12	FCC: Section15.247(b)(1) ISED: RSS-247 5.4 (b)		Complied	Conducted	
Spurious Emission & Band Edge Compliance	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.13	FCC: Section15.247(d) ISED: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10		6.9 dB 2483.5 MHz, AV, Vert.	Complied	Conducted/ Radiated (above 30 MHz) *1)
Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593. * In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred. *1) Radiated test was selected over 30 MHz based on section 15.247(d).						

FCC Part 15.31 (e)

The RF Module has its own regulator.
The RF Module is constantly provided voltage through the regulator regardless of input voltage.
Therefore, this EUT complies with the requirement.

FCC Part 15.203/212 Antenna requirement

The antenna is not removable from the EUT.
Therefore, the equipment complies with the antenna requirement of Section 15.203/212.

3.3 Addition to Standard

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
99% Occupied Bandwidth	ISED: RSS-Gen 6.7	ISED: -	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement. Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Conducted emission

Item	Frequency range	Unit	Calculated Uncertainty (+/-)
AMN (LISN)	0.15 MHz to 30 MHz	dB	3.3

Radiated emission

Measurement distance	Frequency range	Unit	Calculated Uncertainty (+/-)
3 m	9 kHz to 30 MHz	dB	3.3
10 m		dB	3.1
3 m	30 MHz to 200 MHz	Horizontal	4.7
		Vertical	4.7
	200 MHz to 1000 MHz	Horizontal	4.8
		Vertical	6.0
10 m	30 MHz to 200 MHz	Horizontal	5.2
		Vertical	5.1
	200 MHz to 1000 MHz	Horizontal	5.2
		Vertical	5.2
3 m	1 GHz to 6 GHz	dB	5.0
	6 GHz to 18 GHz	dB	5.2
1 m	10 GHz to 18 GHz	dB	5.3
	18 GHz to 26.5 GHz	dB	5.2
	26.5 GHz to 40 GHz	dB	4.7
0.5 m	26.5 GHz to 40 GHz	dB	4.8

Antenna Terminal Conducted

Item	Unit	Calculated Uncertainty (+/-)
Antenna terminated conducted emission / Power density / Burst power	dB	3.47
Adjacent channel power (ACP)	dB	2.28
Bandwidth (OBW)	%	0.96
Time readout (time span upto 100 msec)	%	0.11
Time readout (time span upto 1000 msec)	%	0.11
Time readout (time span upto 60 sec)	%	0.02
Power measurement (Power meter < 8 GHz)	dB	1.46
Power measurement (Call box < 6 GHz)	dB	1.69
Frequency readout (Frequency counter)	ppm	0.67
Frequency readout (Spectrum analyzer frequency readout function)	ppm	2.13
Temperature (constant temperature bath)	deg. C	0.69
Humidity (constant temperature bath)	%RH	2.98
Modulation characteristics	%	6.93
Frequency for mobile	ppm	0.08
Contention-based protocol	dB	2.26

3.5 Test Location

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 Japan

Telephone: +81-596-24-8999

A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 884919

ISED Lab Company Number: 2973C / CAB identifier: JP0002

Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.10 shielded room	3.8 x 2.8 x 2.8	3.8 x 2.8	-	-
No.11 measurement room	4.0 x 3.4 x 2.5	N/A	-	-
No.12 measurement room	2.6 x 3.4 x 2.5	N/A	-	-
Large Chamber	16.9 x 22.1 x 10.17	16.9 x 22.1	-	10 m
Small Chamber	5.3 x 6.69 x 3.59	5.3 x 6.69	-	-

* Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0 m for No.1, No.2, No.3, No.4, and No.5 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test Data, Test Instruments, and Test Set Up

Refer to APPENDIX.

SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

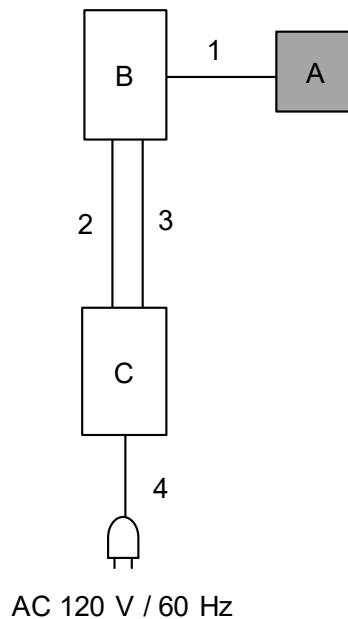
Mode	Remarks*
Bluetooth (BT)	BR / EDR, Payload: PRBS9
<p>*EUT has the power settings by the software as follows; Power Setting: Config:0046 Software: Cybluetool 0.1.97.1 (Date: April 2, 2024, Storage location: Driven by connected PC)</p> <p>*This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.</p>	

Details of Operating Mode(s)

Test Item	Mode	Hopping	Tested Frequency
Conducted Emission, Radiated Spurious Emission (Below 1 GHz)	Tx 3DH5 *1)	Off	2441 MHz
Radiated Spurious Emission (Above 1 GHz),	Tx DH5 Tx 3DH5	Off	2402 MHz 2441 MHz 2480 MHz
Carrier Frequency Separation	Tx DH5 Tx 3DH5	On	2402 MHz 2441 MHz 2480 MHz
20dB Bandwidth	Tx DH5 Tx 3DH5	Off	2402 MHz 2441 MHz 2480 MHz
Number of Hopping Frequency	Tx DH5 Tx 3DH5	On	-
Dwell time	Tx DH1, DH3, DH5 Tx 3DH1, 3DH3, 3DH5	On	-
Maximum Peak Output Power	Tx DH5 Tx 2DH5 Tx 3DH5	Off	2402 MHz 2441 MHz 2480 MHz
Band Edge Compliance (Conducted)	Tx DH5 Tx 3DH5	On ----- Off	2402 MHz 2480 MHz
99% Occupied Bandwidth	Tx DH5 Tx 3DH5	On ----- Off	2402 MHz 2441 MHz 2480 MHz
<p>*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload length (except Dwell time test) *2DH mode (2Mb/s EDR: pi/4DQPSK) was excluded for other tests than power measurement by using 3DH mode (3 Mb/s EDR: 8DPSK) as a representative. *It is considered that the non-tested packet type (e.g. inquiry) can be omitted as it is complied with above all the test items based on Bluetooth Core specification.</p>			
<p>*1) Conducted emissions and Spurious emissions for frequencies below 1 GHz were limited to the channel that had the highest power during the antenna terminal test, as preliminary testing indicated that changing the operating frequency had no significant impact on the emissions in those frequency bands.</p>			

4.2 Configuration and Peripherals

Conducted Emission test



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

*As a result of comparing AC 120 V and AC 240 V at pre-check, conducted emission test was performed with AC 120 V of the worst voltage as representative.

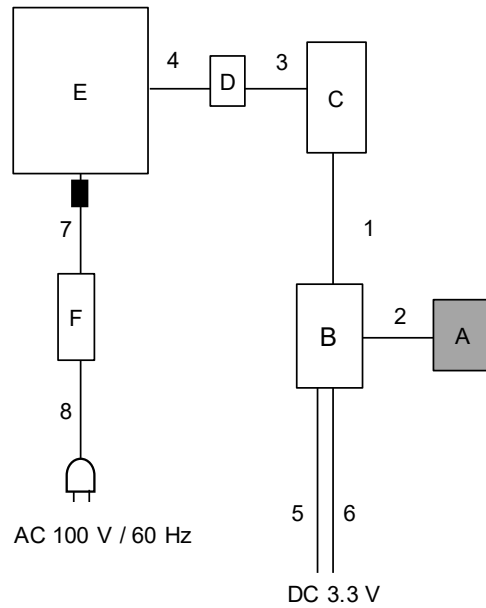
Description of EUT and Support Equipment

No.	Item	Model number	Serial Number	Manufacturer	Remarks
A	Communication Module	2FJ	No.12	Murata Manufacturing Co., Ltd.	EUT
B	Jig Board	P2ML10082	-	Murata Manufacturing Co., Ltd.	-
C	DC Power Supply	PMC35-2A	RM00298	Kikusui Electronics Corp.	-

List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	Flat Cable	0.1	Unshielded	Unshielded	-
2	DC Cable	2.6	Unshielded	Unshielded	-
3	DC Cable	2.6	Unshielded	Unshielded	-
4	AC Cable	1.8	Unshielded	Unshielded	-

Antenna Terminal Conducted Tests



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

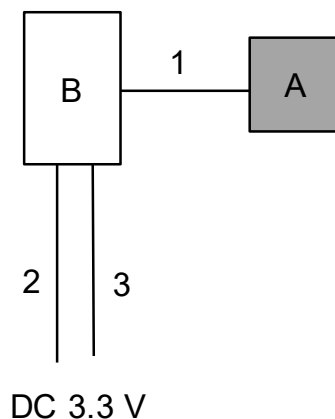
Description of EUT and Support Equipment

No.	Item	Model number	Serial Number	Manufacturer	Remarks
A	Communication Module	2FJ	No.12	Murata Manufacturing Co., Ltd.	EUT
B	Jig Board	P2ML10082	-	Murata Manufacturing Co., Ltd.	-
C	Jig Board	P2ML1188	-	Murata Manufacturing Co., Ltd.	-
D	RS-232C to USB Connector	BSUSRC06	0065252	BUFFALO INC.	-
E	Laptop PC	CF-MX4	5FKSA17992	PANASONIC	-
F	AC Adapter	CF-AA62J2C	62J2CM2152251438SB	Panasonic	-

List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	Signal Cable	0.15	Unshielded	Unshielded	-
2	Flat Cable	0.10	Unshielded	Unshielded	-
3	RS-232C Cable	1.50	Shielded	Shielded	-
4	USB Cable	1.00	Shielded	Shielded	-
5	DC Cable	0.40	Unshielded	Unshielded	-
6	DC Cable	2.30	Unshielded	Unshielded	-
7	DC Cable	1.60	Unshielded	Unshielded	-
8	AC Cable	0.80	Unshielded	Unshielded	-

Radiated Emission test



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support Equipment

No.	Item	Model number	Serial Number	Manufacturer	Remarks
A	Communication Module	2FJ	No.12	Murata Manufacturing Co., Ltd.	EUT
B	Jig Board	P2ML10082	-	Murata Manufacturing Co., Ltd.	-

List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	Flat Cable	0.1	Unshielded	Unshielded	-
2	DC Cable	2.6	Unshielded	Unshielded	-
3	DC Cable	2.6	Unshielded	Unshielded	-

SECTION 5: Conducted Emission

Test Procedure and Conditions

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals was aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80 cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN) / Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. All unused 50 ohm connectors of the LISN (AMN) were resistivity terminated in 50 ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

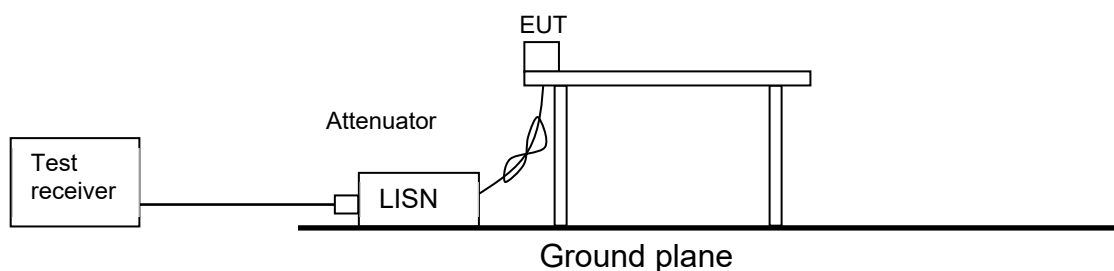
The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

Test results are rounded off and limit are rounded down, so some differences might be observed.

Detector	: QP and CISPR AV
Measurement Range	: 0.15 MHz to 30 MHz
Test Data	: APPENDIX
Test Result	: Pass

Figure 1: Test Setup



SECTION 6: Radiated Spurious Emission

Test Procedure

[For below 1 GHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane. Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

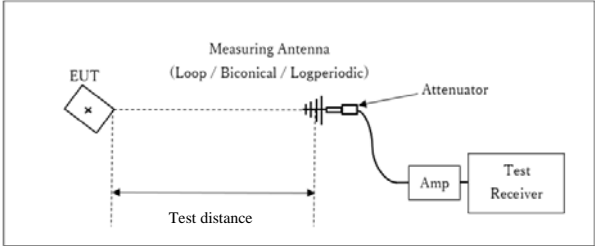
In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9 (ISED) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (ISED).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces Duty factor was added to the results.	RBW: 100 kHz VBW: 300 kHz

Figure 2: Test Setup

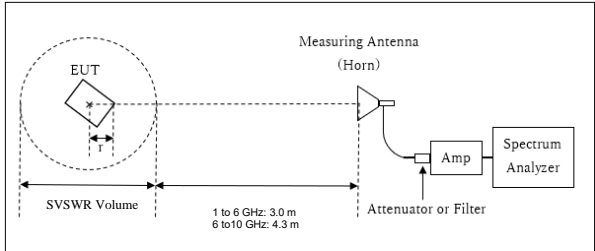
Below 1 GHz



* : Center of turn table

Test Distance: 3 m

1 GHz to 10 GHz



r : Radius of an outer periphery of EUT
 * : Center of turn table

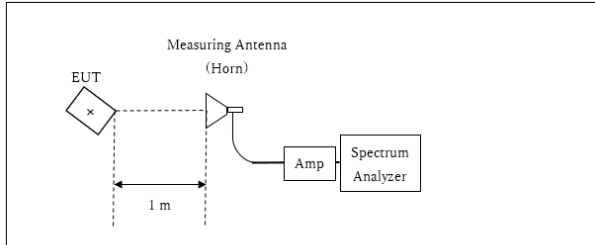
[1 GHz to 6 GHz]
 Distance Factor: $20 \times \log(4.0 \text{ m} / 3.0 \text{ m}) = 2.5 \text{ dB}$
 * Test Distance: $(3 + \text{SVSWR Volume} / 2) - r = 4.0 \text{ m}$

SVSWR Volume : 2.0 m
 (SVSWR Volume has been calibrated based on CISPR 16-1-4.)
 r = 0.0 m

[6 GHz to 10 GHz]
 Distance Factor: $20 \times \log(5.0 \text{ m} / 3.0 \text{ m}) = 4.44 \text{ dB}$
 * Test Distance: $(4.3 + \text{SVSWR Volume} / 2) - r = 5.0 \text{ m}$

SVSWR Volume : 1.4 m
 (SVSWR Volume has been calibrated based on CISPR 16-1-4.)
 r = 0.0 m

10 GHz to 26.5 GHz



* : Center of turn table

Distance Factor: $20 \times \log(1.0 \text{ m} / 3.0 \text{ m}) = -9.54 \text{ dB}$
 *Test Distance: 1 m

The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test results are rounded off and limit are rounded down, so some differences might be observed.

Measurement Range : 30 MHz to 26.5 GHz
 Test Data : APPENDIX
 Test Result : Pass

SECTION 7: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument Used
20dB Bandwidth	3 MHz	30 kHz	100 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak/Average *2)	-	Power Meter (Sensor: 50MHz BW)
Carrier Frequency Separation	3 MHz	30 kHz	100 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Number of Hopping Frequency	30 MHz	200 kHz	620 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Dwell Time	Zero Span	100 kHz, 1 MHz	300 kHz, 3 MHz	As necessary capture the entire dwell time per hopping channel	Peak	Clear Write	Spectrum Analyzer
Conducted Spurious Emission *3) *4)	9 kHz to 150 kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150 kHz to 30 MHz	10 kHz	30 kHz				
	30 MHz to 25 GHz	100 kHz	300 kHz				
Conducted Spurious Emission Band Edge compliance	10 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer

*1) Peak hold was applied as Worst-case measurement.

*2) Reference data

*3) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.

Then, wide-band noise near the limit was checked separately, however the noise was low enough as shown in the chart.
(9 kHz - 150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 10 kHz).

*4) The limits in CFR 47, Part 15, Subpart C, paragraph 15.209(a), are identical to those in RSS-Gen section 8.9, Table 6, since the measurements are performed in terms of magnetic field strength and converted to electric field strength levels (as reported in the table) using the free space impedance of 377 Ohms. For example, the measurement at frequency 9 kHz resulted in a level of 45.5 dBuV/m, which is equivalent to $45.5 - 51.5 = -6.0$ dBuA/m, which has the same margin, 3 dB, to the corresponding RSS-Gen Table 6 limit as it has to 15.209(a) limit.

Test results are rounded off and limit are rounded down, so some differences might be observed.
The equipment and cables were not used for factor 0 dB of the data sheets.

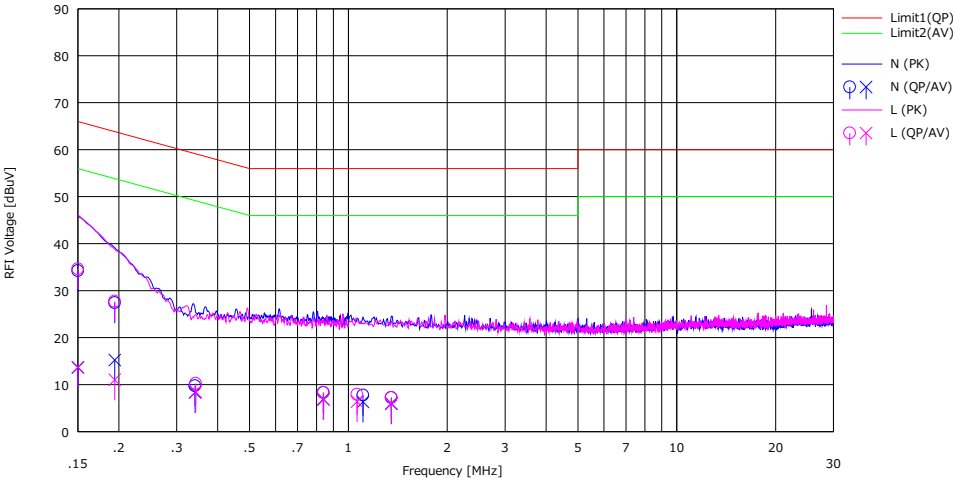
Test Data : APPENDIX
Test Result : Pass

APPENDIX 1: Test data

Conducted Emission

Test place Ise EMC Lab. No.3 Semi Anechoic Chamber
 Date April 24, 2024
 Temperature / Humidity 21 deg. C / 50 % RH
 Engineer Hiroyuki Furutaka
 Mode Tx, Hopping Off, 3DH5 2441 MHz

Limit : FCC_Part 15 Subpart C(15.207)



No.	Freq. [MHz]	Reading		USN [dB]	LOSS [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]			<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]				
1	0.15000	21.10	0.50	0.05	13.08	34.23	13.63	66.00	56.00	31.77	42.37	N	
2	0.19420	14.30	2.10	0.04	13.08	27.42	15.22	63.85	53.85	36.43	38.63	N	
3	0.34125	-3.40	-4.80	0.04	13.09	9.73	8.33	59.17	49.17	49.44	40.84	N	
4	0.83850	-4.90	-6.30	0.06	13.14	8.30	6.90	56.00	46.00	47.70	39.10	N	
5	1.10800	-5.50	-6.90	0.06	13.17	7.73	6.33	56.00	46.00	48.27	39.67	N	
6	1.35100	-6.00	-7.30	0.06	13.18	7.24	5.94	56.00	46.00	48.76	40.06	N	
7	0.15000	21.50	0.60	0.05	13.08	34.63	13.73	66.00	56.00	31.37	42.27	L	
8	0.19420	14.60	-2.10	0.04	13.08	27.72	11.02	63.85	53.85	36.13	42.83	L	
9	0.34295	-2.90	-4.70	0.05	13.09	10.24	8.44	59.13	49.13	48.89	40.69	L	
10	0.84105	-4.90	-6.40	0.06	13.14	8.30	6.80	56.00	46.00	47.70	39.20	L	
11	1.06300	-5.30	-6.80	0.06	13.16	7.92	6.42	56.00	46.00	48.08	39.58	L	
12	1.35100	-6.00	-7.20	0.06	13.18	7.24	6.04	56.00	46.00	48.76	39.96	L	

CHART: WITH FACTOR Peak hold data. CALCULATION : RESULT = READING + LISN + LOSS (CABLE + ATT)
 Except for the above table: adequate margin data below the limits.

20dB Bandwidth, 99%Occupied Bandwidth and Carrier Frequency Separation

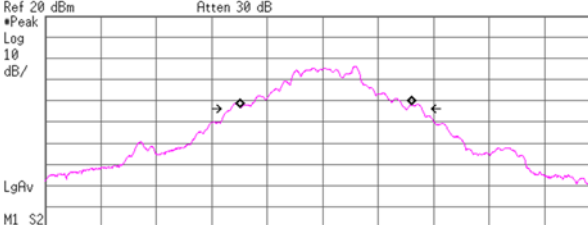
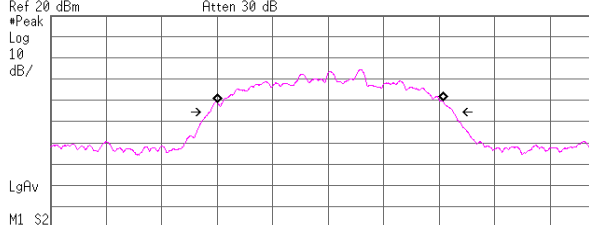
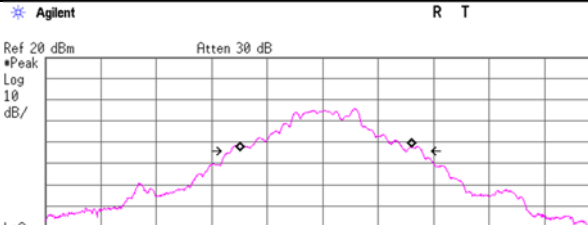
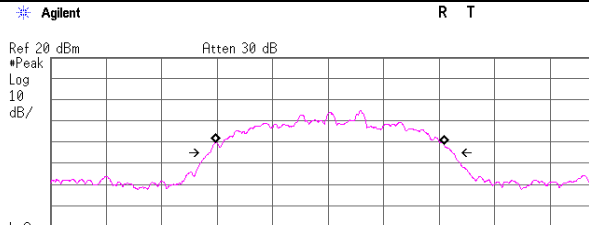
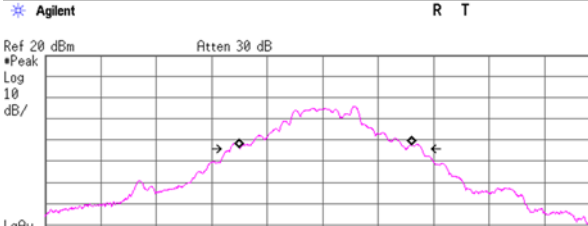
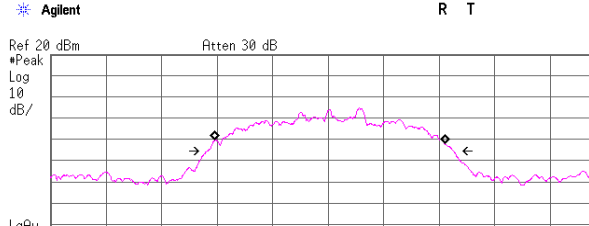
Test place	Ise EMC Lab. No.8 Measurement Room
Date	April 3, 2024
Temperature / Humidity	23 deg. C / 47 % RH
Engineer	Shousei Hamaguchi
Mode	Tx, Hopping Off, Tx, Hopping On

Mode	Freq. [MHz]	20 dB Bandwidth [MHz]	99 % Occupied Bandwidth [kHz]	Carrier Frequency Separation [MHz]	Limit for Carrier Frequency separation [MHz]
DH5	2402.0	1.033	928.253	1.000	>= 0.689
DH5	2441.0	1.031	926.076	1.000	>= 0.687
DH5	2480.0	1.033	931.406	1.000	>= 0.689
DH5	Hopping On	-	78631.600	-	-
3DH5	2402.0	1.319	1219.400	1.000	>= 0.879
3DH5	2441.0	1.321	1234.600	1.000	>= 0.881
3DH5	2480.0	1.327	1245.000	1.000	>= 0.885
3DH5	Hopping On	-	78793.900	-	-

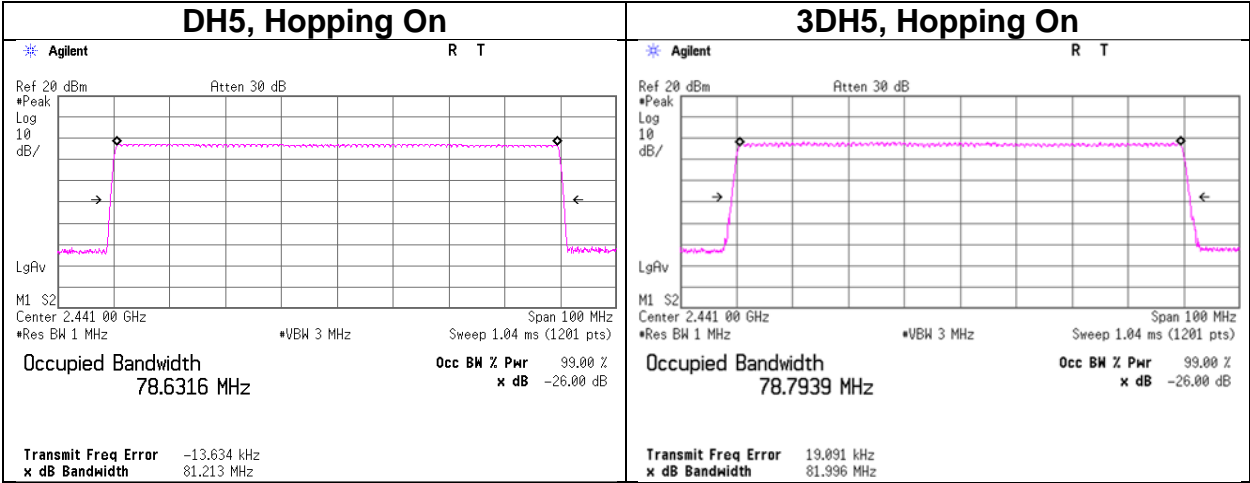
Limit: Two-thirds of 20 dB Bandwidth or 25 kHz (whichever is greater).

No limit applies to 20 dB Bandwidth.

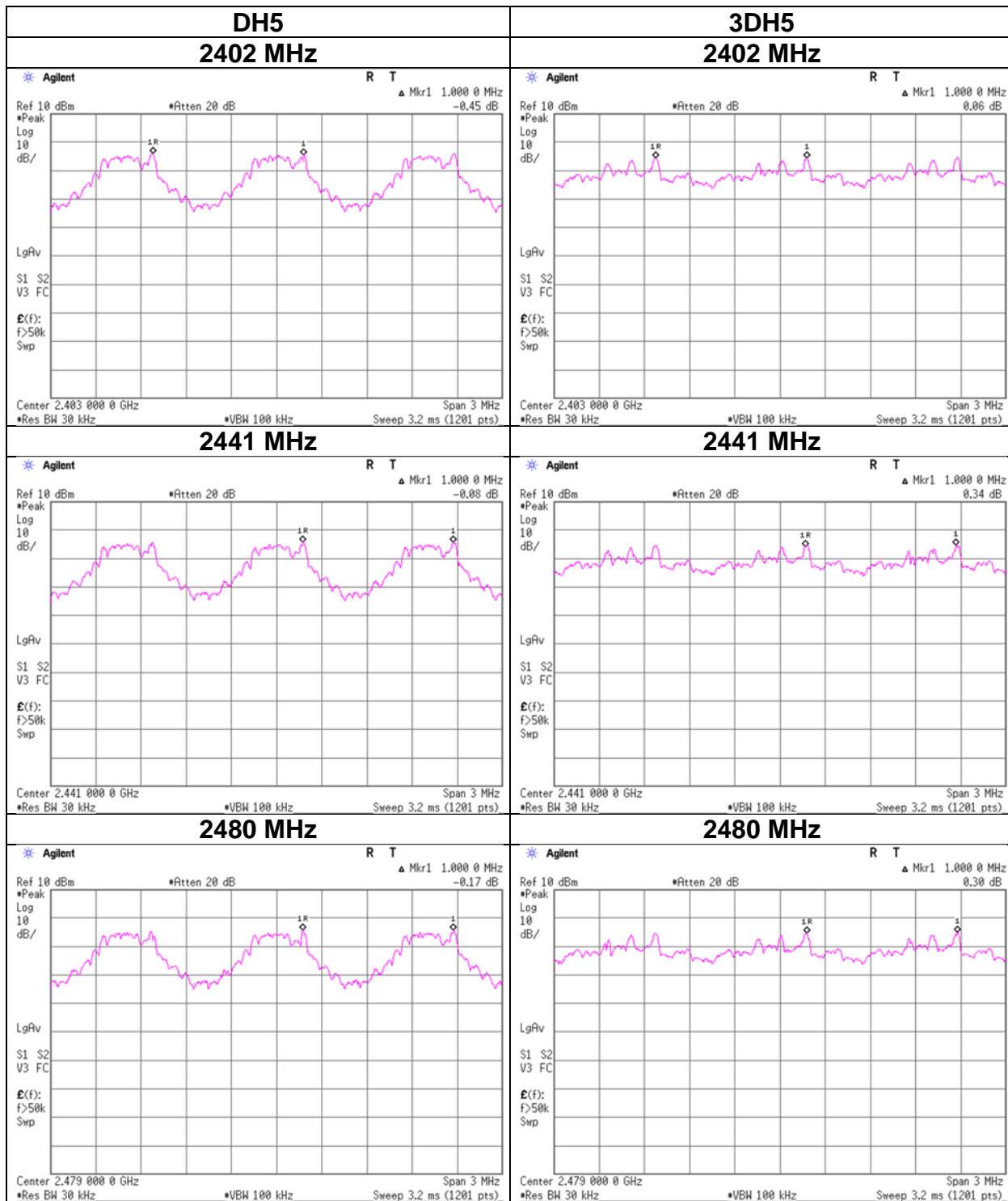
20dB Bandwidth and 99% Occupied Bandwidth

DH5 2402 MHz	3DH5 2402 MHz
<p>Agilent R T</p>  <p>Ref 20 dBm Atten 30 dB</p> <p>Center 2.402 000 GHz Span 3 MHz</p> <p>Occupied Bandwidth 928.2532 kHz</p> <p>Occ BW % Pwr 99.00 % x dB -20.00 dB</p> <p>Transmit Freq Error 17.138 kHz x dB Bandwidth 1.033 MHz</p>	<p>Agilent R T</p>  <p>Ref 20 dBm Atten 30 dB</p> <p>Center 2.402 000 GHz Span 3 MHz</p> <p>Occupied Bandwidth 1.2194 MHz</p> <p>Occ BW % Pwr 99.00 % x dB -20.00 dB</p> <p>Transmit Freq Error 13.147 kHz x dB Bandwidth 1.319 MHz</p>
<p>Agilent R T</p>  <p>Ref 20 dBm Atten 30 dB</p> <p>Center 2.441 000 GHz Span 3 MHz</p> <p>Occupied Bandwidth 926.0759 kHz</p> <p>Occ BW % Pwr 99.00 % x dB -20.00 dB</p> <p>Transmit Freq Error 16.150 kHz x dB Bandwidth 1.031 MHz</p>	<p>Agilent R T</p>  <p>Ref 20 dBm Atten 30 dB</p> <p>Center 2.441 000 GHz Span 3 MHz</p> <p>Occupied Bandwidth 1.2346 MHz</p> <p>Occ BW % Pwr 99.00 % x dB -20.00 dB</p> <p>Transmit Freq Error 11.013 kHz x dB Bandwidth 1.321 MHz</p>
<p>Agilent R T</p>  <p>Ref 20 dBm Atten 30 dB</p> <p>Center 2.480 000 GHz Span 3 MHz</p> <p>Occupied Bandwidth 931.4056 kHz</p> <p>Occ BW % Pwr 99.00 % x dB -20.00 dB</p> <p>Transmit Freq Error 13.279 kHz x dB Bandwidth 1.033 MHz</p>	<p>Agilent R T</p>  <p>Ref 20 dBm Atten 30 dB</p> <p>Center 2.480 000 GHz Span 3 MHz</p> <p>Occupied Bandwidth 1.2450 MHz</p> <p>Occ BW % Pwr 99.00 % x dB -20.00 dB</p> <p>Transmit Freq Error 10.076 kHz x dB Bandwidth 1.327 MHz</p>

20dB Bandwidth and 99% Occupied Bandwidth



Carrier Frequency Separation



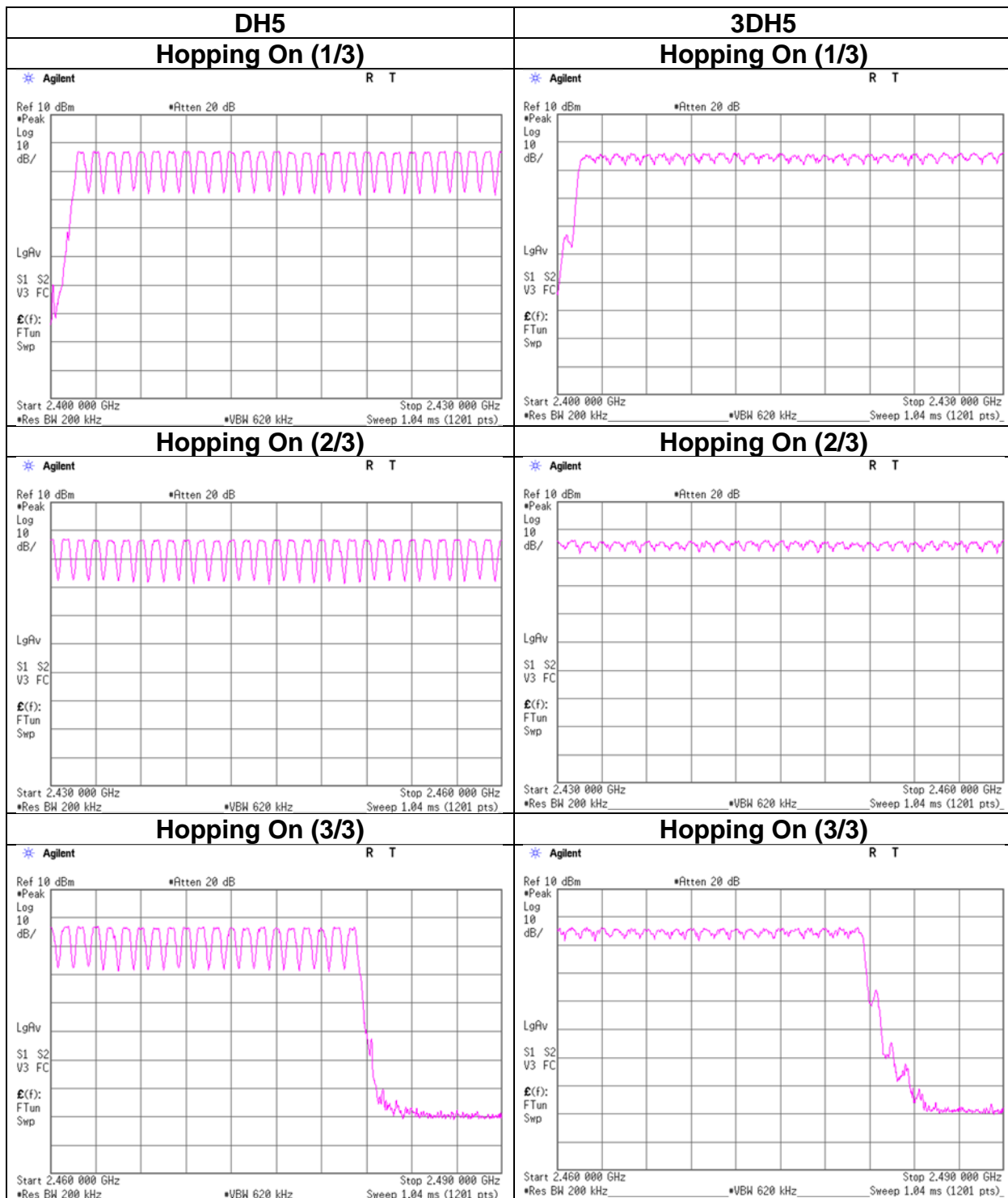
Number of Hopping Frequency

Test place Ise EMC Lab. No.8 Measurement Room
Date April 3, 2024
Temperature / Humidity 23 deg. C / 47 % RH
Engineer Shousei Hamaguchi
Mode Tx, Hopping On

Mode	Number of channel [channels]	Limit [channels]
DH5	79	>= 15
3DH5	79	>= 15

Test was not performed at AFH mode whose number of hopping channel is 20 channels because this Bluetooth radio is in compliance of Bluetooth Specification.

Number of Hopping Frequency



Dwell time

Test place	Ise EMC Lab. No.8 Measurement Room
Date	April 3, 2024
Temperature / Humidity	23 deg. C / 47 % RH
Engineer	Shousei Hamaguchi
Mode	Tx, Hopping On

Mode	Number of transmission in a 31.6 (79 Hopping x 0.4) / 12.8 (32 Hopping x 0.4) second period	Length of transmission [ms]	Result [ms]	Limit [ms]
DH1	50.4 times / 5 s x 31.6 s = 319 times	0.425	136	400
DH3	25.2 times / 5 s x 31.6 s = 160 times	1.687	270	400
DH5	18.8 times / 5 s x 31.6 s = 119 times	2.937	349	400
3DH1	50.4 times / 5 s x 31.6 s = 319 times	0.429	137	400
3DH3	26.2 times / 5 s x 31.6 s = 166 times	1.690	280	400
3DH5	16.4 times / 5 s x 31.6 s = 104 times	2.947	306	400

Sample Calculation

Result = Number of transmission x Length of transmission

*Average data of 5 tests.(except Inquiry)

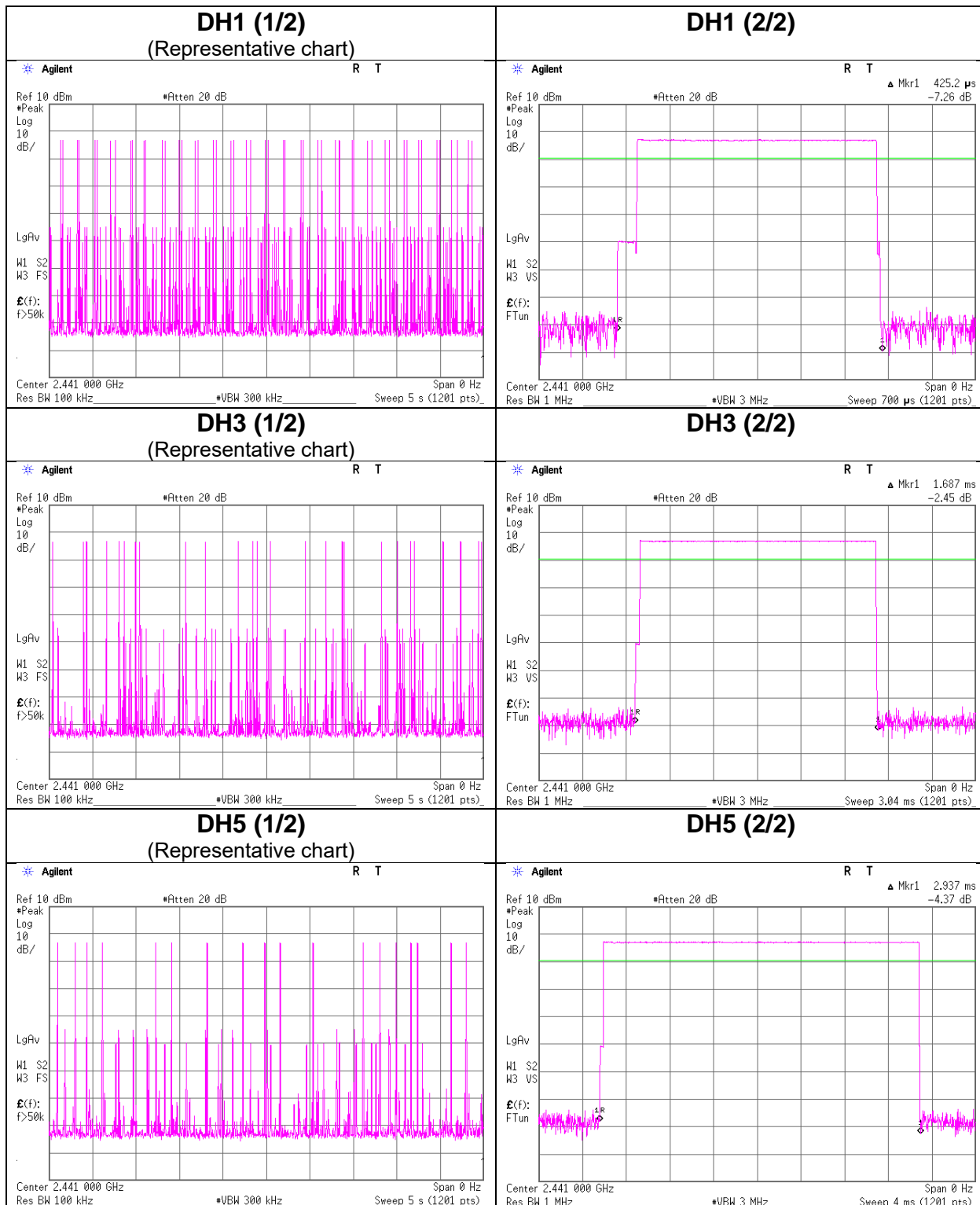
Mode	Sampling [times]					Average [times]
	1	2	3	4	5	
DH1	50	52	50	50	50	50.4
DH3	26	28	22	24	26	25.2
DH5	18	19	17	21	19	18.8
3DH1	51	51	50	51	49	50.4
3DH3	28	25	23	25	30	26.2
3DH5	16	16	21	13	16	16.4

Sample Calculation

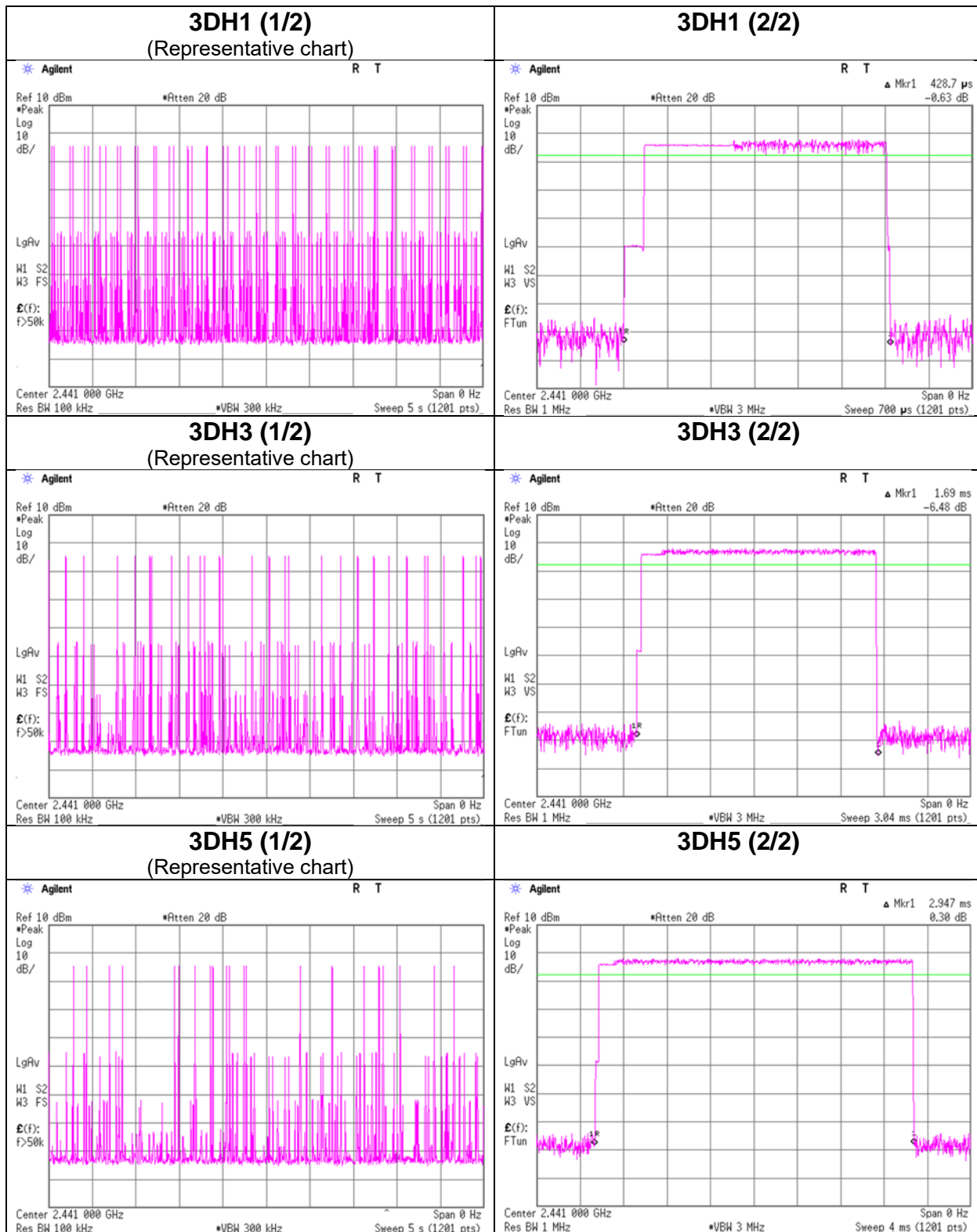
Average = Summation (Sampling 1 to 5) / 5

This device complies with the Bluetooth protocol for FHSS operation, employing a pseudo random channel selection and hopping rate to ensure that the occupancy time in $N \times 0.4$ s, where N is the number of channels being used in the hopping sequence ($20 \leq N \leq 79$), is always less than 0.4 s regardless of packet size. This is confirmed in the test report for $N = 79$.

Dwell time



Dwell time



Maximum Peak Output Power

Test place Ise EMC Lab. No.8 Measurement Room
Date April 3, 2024
Temperature / Humidity 23 deg. C / 47 % RH
Engineer Shousei Hamaguchi
Mode Tx, Hopping Off

Mode	Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Conducted Power					e.i.r.p. for RSS-247					
					Result		Limit		Margin	Antenna Gain [dBi]	Result		Limit		Margin
					[dBm]	[mW]	[dBm]	[mW]			[dBm]	[mW]	[dBm]	[mW]	
DH5	2402.0	-1.86	0.50	9.98	8.62	7.28	20.96	125	12.34	1.33	9.95	9.89	36.02	4000	26.07
DH5	2441.0	-2.02	0.50	9.98	8.46	7.01	20.96	125	12.50	1.33	9.79	9.53	36.02	4000	26.23
DH5	2480.0	-2.01	0.50	9.98	8.47	7.03	20.96	125	12.49	1.33	9.80	9.55	36.02	4000	26.22
2DH5	2402.0	-1.14	0.50	9.98	9.34	8.59	20.96	125	11.62	1.33	10.67	11.67	36.02	4000	25.35
2DH5	2441.0	-1.00	0.50	9.98	9.48	8.87	20.96	125	11.48	1.33	10.81	12.05	36.02	4000	25.21
2DH5	2480.0	-1.23	0.50	9.98	9.25	8.41	20.96	125	11.71	1.33	10.58	11.43	36.02	4000	25.44
3DH5	2402.0	-1.00	0.50	9.98	9.48	8.87	20.96	125	11.48	1.33	10.81	12.05	36.02	4000	25.21
3DH5	2441.0	-0.89	0.50	9.98	9.59	9.10	20.96	125	11.37	1.33	10.92	12.36	36.02	4000	25.10
3DH5	2480.0	-1.05	0.50	9.98	9.43	8.77	20.96	125	11.53	1.33	10.76	11.91	36.02	4000	25.26

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

e.i.r.p. Result = Conducted Power Result + Antenna Gain

Test was not performed at AFH mode, because the decrease of number of channel (min: 20 ch) at AFH mode does not influence on the output power and bandwidth of the EUT.

As this device had AFH mode and frequency separation could not meet the requirement of over 20 dB BW without 2/3 relaxation, 125 mW power limit was applied to it.

Average Output Power
(Reference data for RF Exposure)

Test place Ise EMC Lab. No.8 Measurement Room
Date April 3, 2024
Temperature / Humidity 23 deg. C / 47 % RH
Engineer Shousei Hamaguchi
Mode Tx, Hopping Off

Mode	Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result (Time average)		Duty factor [dB]	Result (Burst power average)	
					[dBm]	[mW]		[dBm]	[mW]
DH5	2402.0	-3.26	0.50	9.98	7.22	5.27	1.08	8.30	6.76
DH5	2441.0	-3.45	0.50	9.98	7.03	5.05	1.08	8.11	6.47
DH5	2480.0	-3.53	0.50	9.98	6.95	4.95	1.08	8.03	6.35
2DH5	2402.0	-4.67	0.50	9.98	5.81	3.81	1.07	6.88	4.88
2DH5	2441.0	-4.30	0.50	9.98	6.18	4.15	1.07	7.25	5.31
2DH5	2480.0	-4.38	0.50	9.98	6.10	4.07	1.07	7.17	5.21
3DH5	2402.0	-4.65	0.50	9.98	5.83	3.83	1.07	6.90	4.90
3DH5	2441.0	-4.29	0.50	9.98	6.19	4.16	1.07	7.26	5.32
3DH5	2480.0	-4.26	0.50	9.98	6.22	4.19	1.07	7.29	5.36

Sample Calculation:

Result (Time average) = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

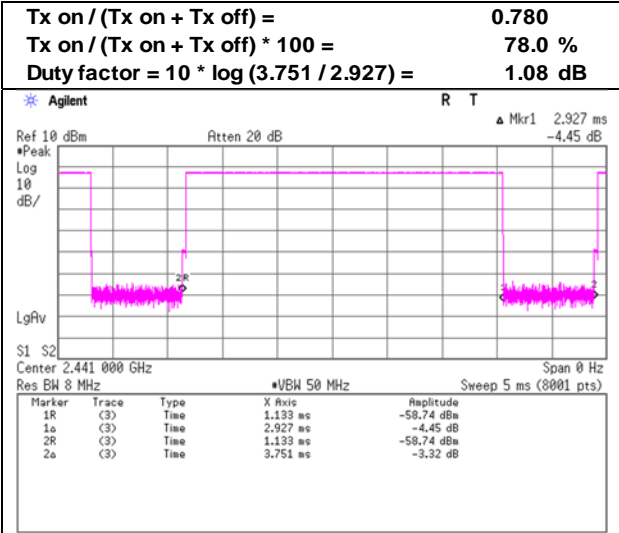
Result (Burst power average) = Time average + Duty factor

*The equipment and cables were not used for factor 0 dB of the data sheets.

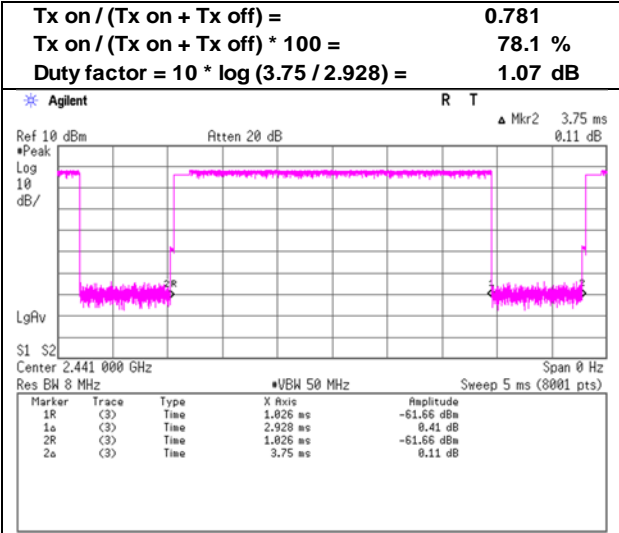
Burst Rate Confirmation

Test place Ise EMC Lab. No.8 Measurement Room
 Date April 3, 2024
 Temperature / Humidity 23 deg. C / 47 % RH
 Engineer Shousei Hamaguchi
 Mode Tx, Hopping Off

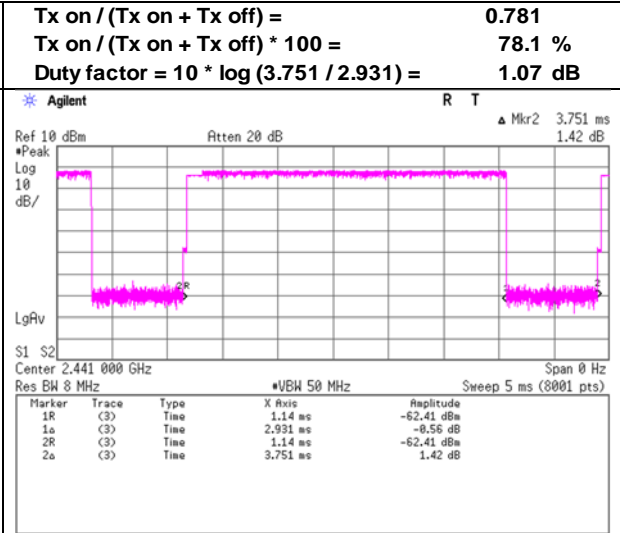
DH5



2DH5



3DH5



Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.3
Date	April 14, 2024	April 15, 2024
Temperature / Humidity	21 deg. C / 40 % RH	20 deg. C / 51 % RH
Engineer	Shousei Hamaguchi	Tomoya Sone
	(1 GHz to 10 GHz)	(Above 10 GHz)
Mode	Tx, Hopping Off, DH5 2402 MHz	

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Duty Factor	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	2390.0	42.2	33.8	27.5	5.5	32.2	1.1	43.0	35.6	73.9	53.9	30.9	18.3	*1)
Hori.	4804.0	40.1	33.1	31.4	7.6	31.2	1.1	47.9	42.0	73.9	53.9	26.0	11.9	
Hori.	7206.0	41.5	33.6	35.6	10.7	32.0	-	55.8	47.9	73.9	53.9	18.1	6.0	Floor noise
Hori.	9608.0	40.4	33.2	35.6	11.2	32.6	-	54.6	47.4	73.9	53.9	19.3	6.5	Floor noise
Vert.	2390.0	42.6	34.0	27.5	5.5	32.2	1.1	43.4	35.9	73.9	53.9	30.5	18.0	*1)
Vert.	4804.0	41.5	35.0	31.4	7.6	31.2	1.1	49.3	43.8	73.9	53.9	24.6	10.1	
Vert.	7206.0	41.5	33.6	35.6	10.7	32.0	-	55.8	47.9	73.9	53.9	18.1	6.0	Floor noise
Vert.	9608.0	40.4	33.2	35.6	11.2	32.6	-	54.6	47.4	73.9	53.9	19.3	6.5	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*QP detector was used up to 1GHz.

*1) Not Out of Band emission(Leakage Power)

20dBc Data Sheet

Polarity	Frequency	Reading (PK)	Ant Factor	Loss	Gain	Result	Limit	Margin	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	2402.0	101.7	27.5	5.5	32.2	102.5	-	-	Carrier
Hori.	2400.0	45.8	27.5	5.5	32.2	46.6	82.5	35.9	
Vert.	2402.0	101.9	27.5	5.5	32.2	102.7	-	-	Carrier
Vert.	2400.0	46.0	27.5	5.5	32.2	46.8	82.7	36.0	

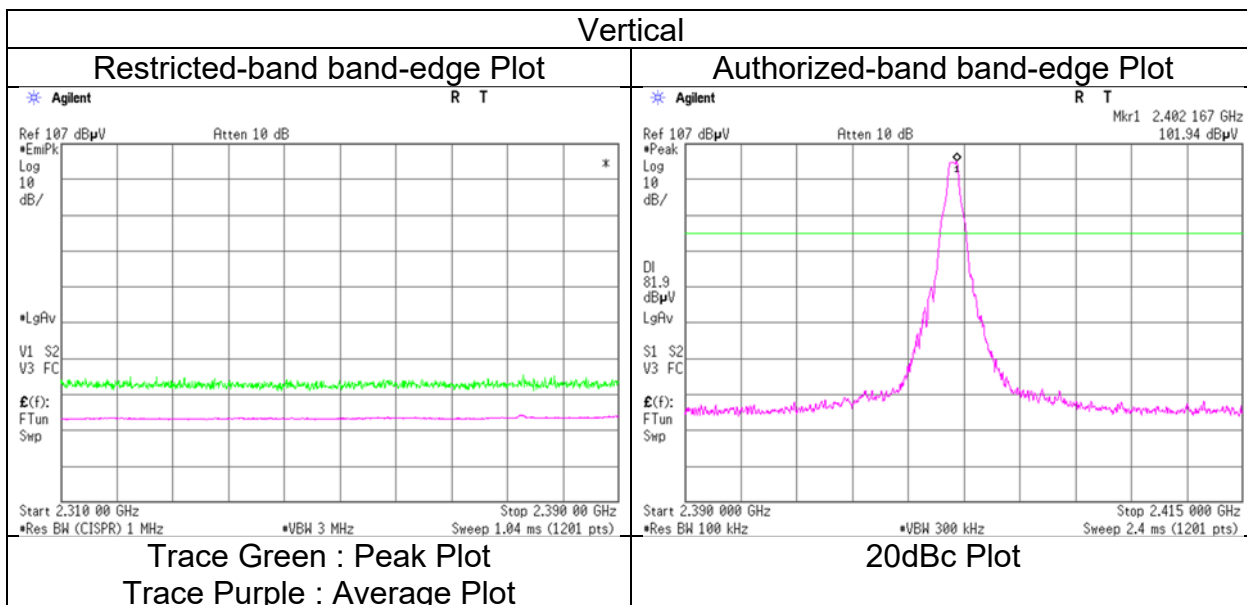
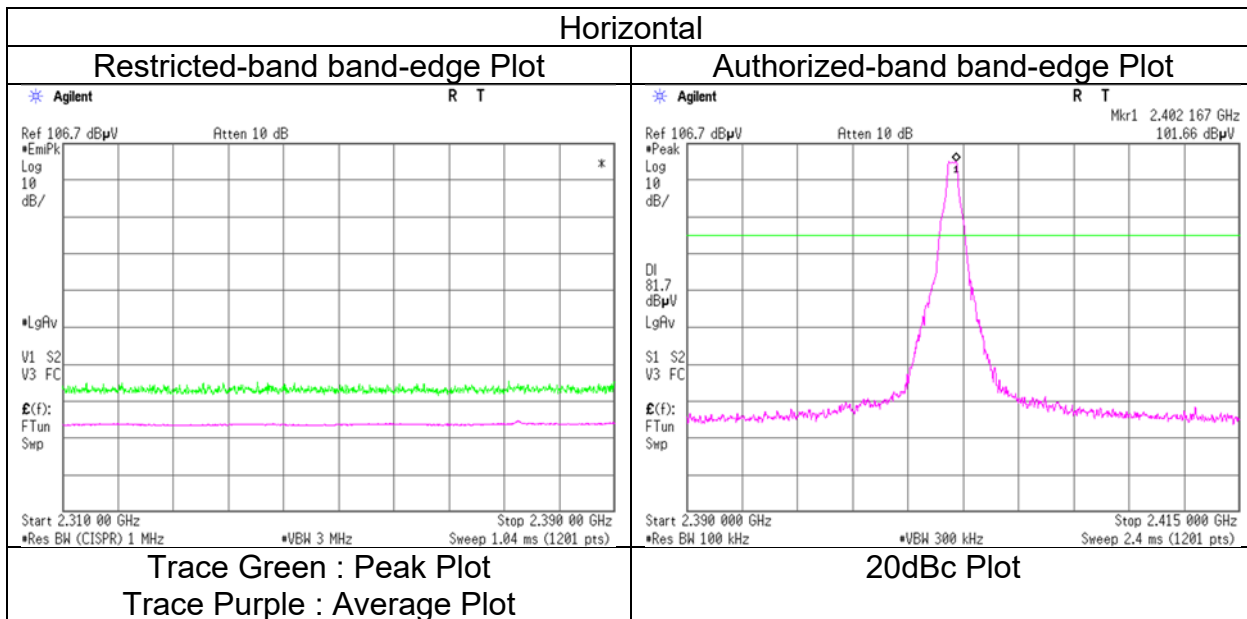
Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Distance factor:
 1 GHz - 6 GHz 20log (4 m / 3.0 m) = 2.5 dB
 6 GHz - 10 GHz 20log (5 m / 3.0 m) = 4.44 dB
 10 GHz - 40 GHz 20log (1.0 m / 3.0 m) = -9.54 dB

*These results have sufficient margin without taking account Duty cycle correction factor.

Radiated Spurious Emission (Reference Plot for band-edge)

Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	April 14, 2024
Temperature / Humidity	21 deg. C / 40 % RH
Engineer	Shousei Hamaguchi
	(1 GHz to 10 GHz)
Mode	Tx, Hopping Off, DH5 2402 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge and authorized band edge were shown in tabular data.

Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.3
Date	April 14, 2024	April 15, 2024
Temperature / Humidity	21 deg. C / 40 % RH	20 deg. C / 51 % RH
Engineer	Shousei Hamaguchi	Tomoya Sone
	(1 GHz to 10 GHz)	(Above 10 GHz)
Mode	Tx, Hopping Off, DH5 2441 MHz	

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Duty Factor	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	4882.0	42.1	34.4	31.4	7.6	31.2	1.1	50.0	43.4	73.9	53.9	23.9	10.5	
Hori.	7323.0	41.6	33.3	35.6	10.7	32.1	-	55.9	47.5	73.9	53.9	18.0	6.4	Floor noise
Hori.	9764.0	40.5	32.9	35.9	11.3	32.7	-	55.0	47.4	73.9	53.9	18.9	6.5	Floor noise
Vert.	4882.0	40.7	34.7	31.4	7.6	31.2	1.1	48.6	43.7	73.9	53.9	25.3	10.2	
Vert.	7323.0	41.6	33.3	35.6	10.7	32.1	-	55.9	47.5	73.9	53.9	18.0	6.4	Floor noise
Vert.	9764.0	40.5	32.9	35.9	11.3	32.7	-	55.0	47.4	73.9	53.9	18.9	6.5	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*QP detector was used up to 1GHz.

Distance factor:	1 GHz - 6 GHz	20log (4 m / 3.0 m) = 2.5 dB
	6 GHz - 10 GHz	20log (5 m / 3.0 m) = 4.44 dB
	10 GHz - 40 GHz	20log (1.0 m / 3.0 m) = -9.54 dB

Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.3
Date	April 14, 2024	April 15, 2024
Temperature / Humidity	21 deg. C / 40 % RH	20 deg. C / 51 % RH
Engineer	Shousei Hamaguchi	Tomoya Sone
	(1 GHz to 10 GHz)	(Above 10 GHz)
Mode	Tx, Hopping Off, DH5 2480 MHz	

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Duty Factor	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	2483.5	48.3	39.3	27.4	5.6	32.2	1.1	49.0	41.1	73.9	53.9	24.9	12.8	*1)
Hori.	4960.0	40.3	34.5	31.6	7.6	31.1	1.1	48.4	43.7	73.9	53.9	25.5	10.2	
Hori.	7440.0	40.5	33.4	35.5	10.7	32.1	-	54.5	47.4	73.9	53.9	19.4	6.5	Floor noise
Hori.	9920.0	41.6	33.0	36.1	11.3	32.8	-	56.3	47.7	73.9	53.9	17.6	6.2	Floor noise
Vert.	2483.5	47.9	39.7	27.4	5.6	32.2	1.1	48.7	41.5	73.9	53.9	25.2	12.4	*1)
Vert.	4960.0	40.1	34.2	31.6	7.6	31.1	1.1	48.1	43.3	73.9	53.9	25.8	10.6	
Vert.	7440.0	40.5	33.4	35.5	10.7	32.1	-	54.5	47.4	73.9	53.9	19.4	6.5	Floor noise
Vert.	9920.0	41.6	33.0	36.1	11.3	32.8	-	56.3	47.7	73.9	53.9	17.6	6.2	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*QP detector was used up to 1GHz.

*1) Not Out of Band emission(Leakage Power)

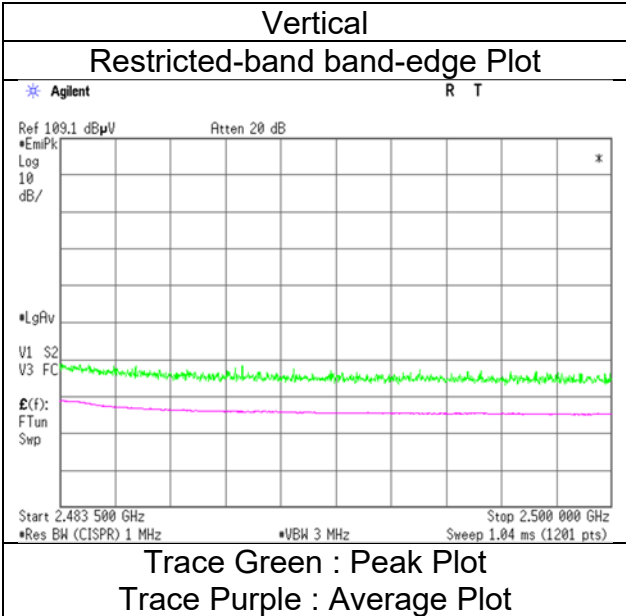
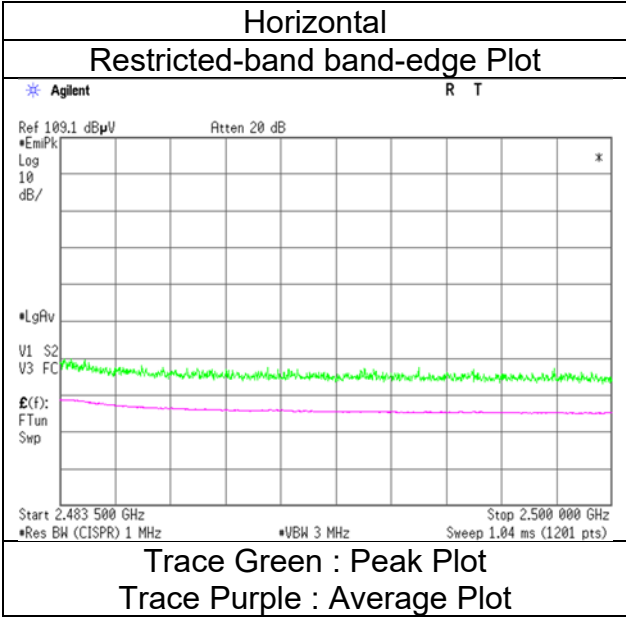
Distance factor:	1 GHz - 6 GHz	20log (4 m / 3.0 m) = 2.5 dB
	6 GHz - 10 GHz	20log (5 m / 3.0 m) = 4.44 dB
	10 GHz - 40 GHz	20log (1.0 m / 3.0 m) = -9.54 dB

**Radiated Spurious Emission
(Reference Plot for bandto edge)**

Test place
Semi Anechoic Chamber
Date
Temperature / Humidity
Engineer

Mode

Ise EMC Lab.
No.3
April 14, 2024
21 deg. C / 40 % RH
Shousei Hamaguchi
(1 GHz to 10 GHz)
Tx, Hopping Off, DH5 2480 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.3
Date	April 14, 2024	April 15, 2024
Temperature / Humidity	21 deg. C / 40 % RH	20 deg. C / 51 % RH
Engineer	Shousei Hamaguchi	Tomoya Sone
	(1 GHz to 10 GHz)	(Above 10 GHz)
Mode	Tx, Hopping Off, 3DH5 2402 MHz	

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Duty Factor	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	2390.0	42.0	34.0	27.5	5.5	32.2	1.1	42.8	35.9	73.9	53.9	31.1	18.0	*1)
Hori.	4804.0	41.3	32.9	31.4	7.6	31.2	1.1	49.2	41.8	73.9	53.9	24.8	12.1	
Hori.	7206.0	41.5	33.6	35.6	10.7	32.0	-	55.8	47.9	73.9	53.9	18.1	6.0	Floor noise
Hori.	9608.0	40.4	33.2	35.6	11.2	32.6	-	54.6	47.4	73.9	53.9	19.3	6.5	Floor noise
Vert.	2390.0	42.7	33.9	27.5	5.5	32.2	1.1	43.5	35.8	73.9	53.9	30.4	18.1	*1)
Vert.	4804.0	40.9	33.9	31.4	7.6	31.2	1.1	48.7	42.8	73.9	53.9	25.2	11.1	
Vert.	7206.0	41.5	33.6	35.6	10.7	32.0	-	55.8	47.9	73.9	53.9	18.1	6.0	Floor noise
Vert.	9608.0	40.4	33.2	35.6	11.2	32.6	-	54.6	47.4	73.9	53.9	19.3	6.5	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*QP detector was used up to 1GHz.

*1) Not Out of Band emission(Leakage Power)

20dBc Data Sheet

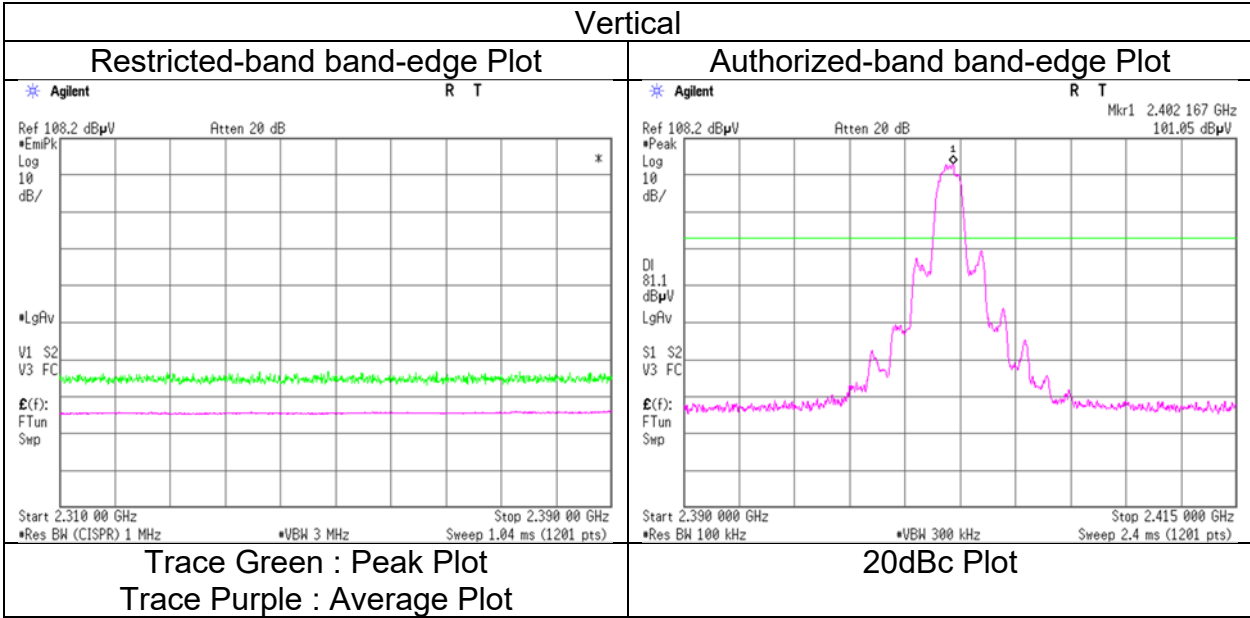
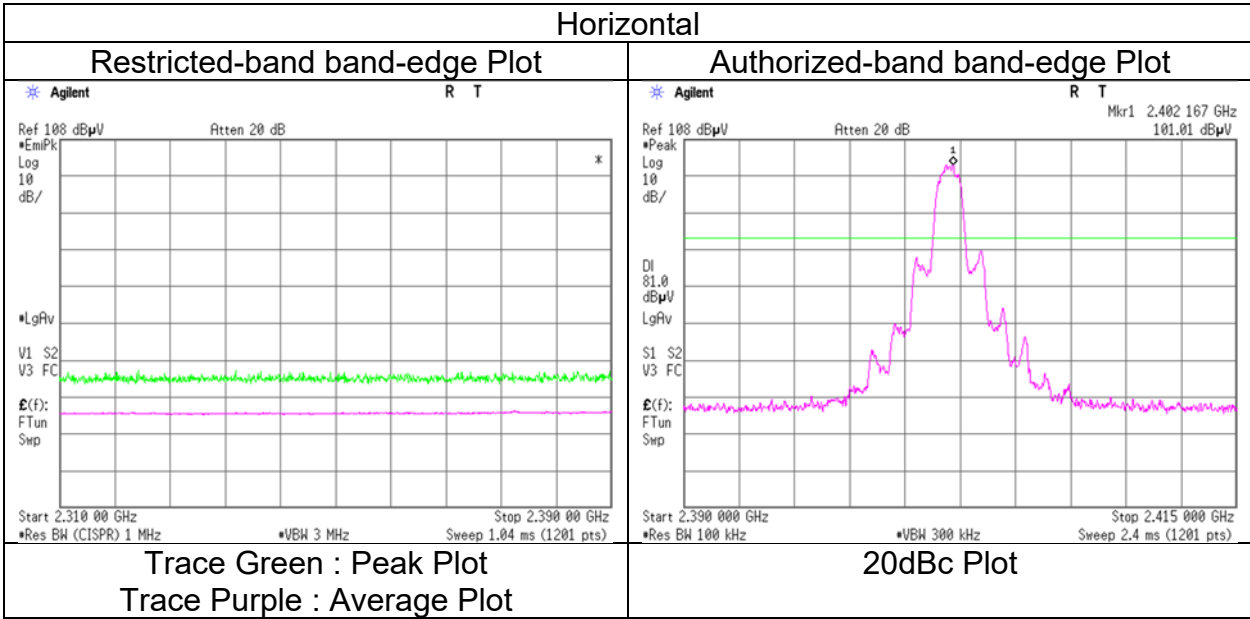
Polarity	Frequency	Reading (PK)	Ant Factor	Loss	Gain	Result	Limit	Margin	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	2402.0	101.0	27.5	5.5	32.2	101.8	-	-	Carrier
Hori.	2400.0	55.4	27.5	5.5	32.2	56.2	81.8	25.6	
Vert.	2402.0	101.1	27.5	5.5	32.2	101.8	-	-	Carrier
Vert.	2400.0	55.4	27.5	5.5	32.2	56.1	81.8	25.7	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Distance factor:
 1 GHz - 6 GHz 20log (4 m / 3.0 m) = 2.5 dB
 6 GHz - 10 GHz 20log (5 m / 3.0 m) = 4.44 dB
 10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.54 dB

**Radiated Spurious Emission
 (Reference Plot for band-edge)**

Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	April 14, 2024
Temperature / Humidity	21 deg. C / 40 % RH
Engineer	Shousei Hamaguchi
	(1 GHz to 10 GHz)
Mode	Tx, Hopping Off, 3DH5 2402 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
 Final result of restricted band edge and authorized band edge were shown in tabular data.

Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.3
Date	April 14, 2024	April 15, 2024
Temperature / Humidity	21 deg. C / 40 % RH	20 deg. C / 51 % RH
Engineer	Shousei Hamaguchi (1 GHz to 10 GHz)	Tomoya Sone (Above 10 GHz and Below 1 GHz)
Mode	Tx, Hopping Off, 3DH5 2441 MHz	

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Duty Factor	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	49.0	23.6	-	11.5	7.2	32.2	-	10.2	-	40.0	-	29.8	-	Floor noise
Hori.	62.3	26.4	-	7.5	7.4	32.2	-	9.1	-	40.0	-	30.9	-	
Hori.	66.6	25.8	-	6.7	7.5	32.2	-	7.8	-	40.0	-	32.2	-	
Hori.	288.0	27.6	-	13.5	9.6	32.0	-	18.7	-	46.0	-	27.3	-	
Hori.	546.4	21.4	-	17.8	11.2	32.1	-	18.3	-	46.0	-	27.7	-	Floor noise
Hori.	861.6	22.4	-	21.7	12.8	31.2	-	25.7	-	46.0	-	20.3	-	Floor noise
Hori.	4882.0	40.7	33.8	31.4	7.6	31.2	1.1	48.5	42.8	73.9	53.9	25.4	11.1	
Hori.	7323.0	41.6	33.3	35.6	10.7	32.1	-	55.9	47.5	73.9	53.9	18.0	6.4	Floor noise
Hori.	9764.0	40.5	32.9	35.9	11.3	32.7	-	55.0	47.4	73.9	53.9	18.9	6.5	Floor noise
Vert.	49.0	23.7	-	11.5	7.2	32.2	-	10.3	-	40.0	-	29.7	-	Floor noise
Vert.	62.3	27.4	-	7.5	7.4	32.2	-	10.1	-	40.0	-	29.9	-	
Vert.	66.6	25.1	-	6.7	7.5	32.2	-	7.1	-	40.0	-	32.9	-	
Vert.	288.0	27.4	-	13.5	9.6	32.0	-	18.5	-	46.0	-	27.5	-	
Vert.	546.4	21.4	-	17.8	11.2	32.1	-	18.3	-	46.0	-	27.7	-	Floor noise
Vert.	861.6	22.4	-	21.7	12.8	31.2	-	25.7	-	46.0	-	20.3	-	Floor noise
Vert.	4882.0	40.5	34.3	31.4	7.6	31.2	1.1	48.4	43.3	73.9	53.9	25.5	10.6	
Vert.	7323.0	41.6	33.3	35.6	10.7	32.1	-	55.9	47.5	73.9	53.9	18.0	6.4	Floor noise
Vert.	9764.0	40.5	32.9	35.9	11.3	32.7	-	55.0	47.4	73.9	53.9	18.9	6.5	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)
 Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor
 *Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).
 *QP detector was used up to 1GHz.

Distance factor: 1 GHz - 6 GHz 20log (4 m / 3.0 m) = 2.5 dB
 6 GHz - 10 GHz 20log (5 m / 3.0 m) = 4.44 dB
 10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.54 dB

Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.3
Date	April 14, 2024	April 15, 2024
Temperature / Humidity	21 deg. C / 40 % RH	20 deg. C / 51 % RH
Engineer	Shousei Hamaguchi	Tomoya Sone
	(1 GHz to 10 GHz)	(Above 10 GHz)
Mode	Tx, Hopping Off, 3DH5 2480 MHz	

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Duty Factor	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	2483.5	55.3	44.5	27.4	5.6	32.2	1.1	56.0	46.3	73.9	53.9	17.9	7.6	*1)
Hori.	4960.0	41.0	33.7	31.6	7.6	31.1	1.1	49.0	42.9	73.9	53.9	24.9	11.1	
Hori.	7440.0	40.5	33.4	35.5	10.7	32.1	-	54.5	47.4	73.9	53.9	19.4	6.5	Floor noise
Hori.	9920.0	41.6	33.0	36.1	11.3	32.8	-	56.3	47.7	73.9	53.9	17.6	6.2	Floor noise
Vert.	2483.5	56.0	45.2	27.4	5.6	32.2	1.1	56.8	47.0	73.9	53.9	17.1	6.9	*1)
Vert.	4960.0	41.5	33.7	31.6	7.6	31.1	1.1	49.5	42.8	73.9	53.9	24.4	11.1	
Vert.	7440.0	40.5	33.4	35.5	10.7	32.1	-	54.5	47.4	73.9	53.9	19.4	6.5	Floor noise
Vert.	9920.0	41.6	33.0	36.1	11.3	32.8	-	56.3	47.7	73.9	53.9	17.6	6.2	Floor noise

Result (QP / PK) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV) = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*QP detector was used up to 1GHz.

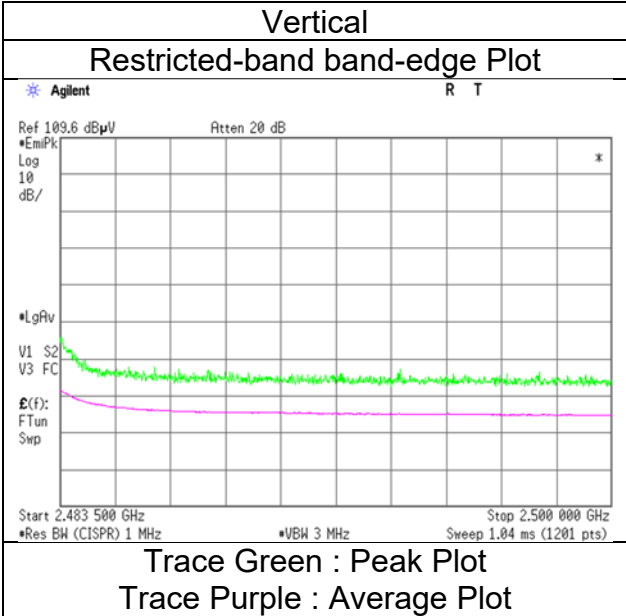
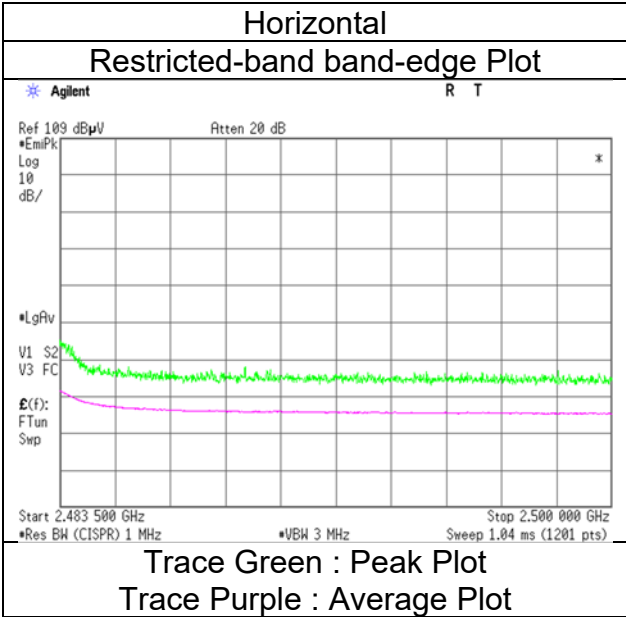
*1) Not Out of Band emission(Leakage Power)

Distance factor:	1 GHz - 6 GHz	20log (4 m / 3.0 m) = 2.5 dB
	6 GHz - 10 GHz	20log (5 m / 3.0 m) = 4.44 dB
	10 GHz - 26.5 GHz	20log (1.0 m / 3.0 m) = -9.54 dB

**Radiated Spurious Emission
 (Reference Plot for band-edge)**

Test place
 Semi Anechoic Chamber
 Date
 Temperature / Humidity
 Engineer
 Mode

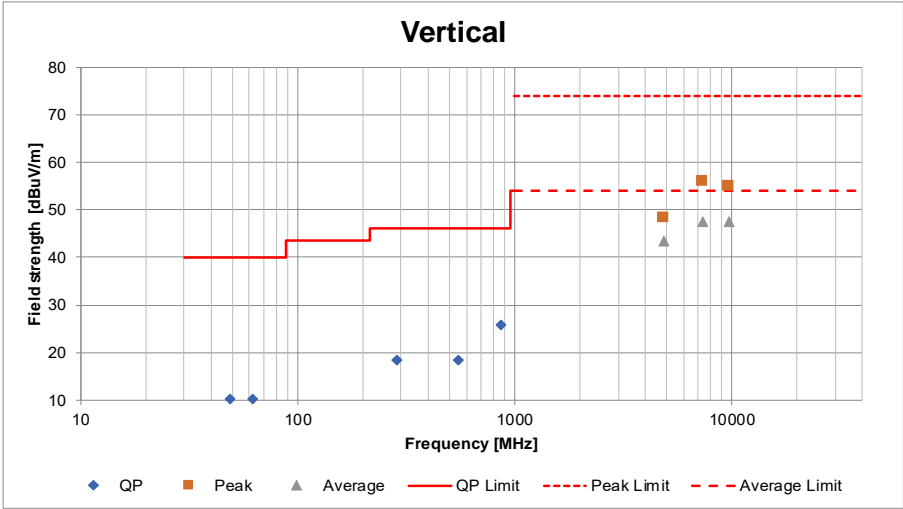
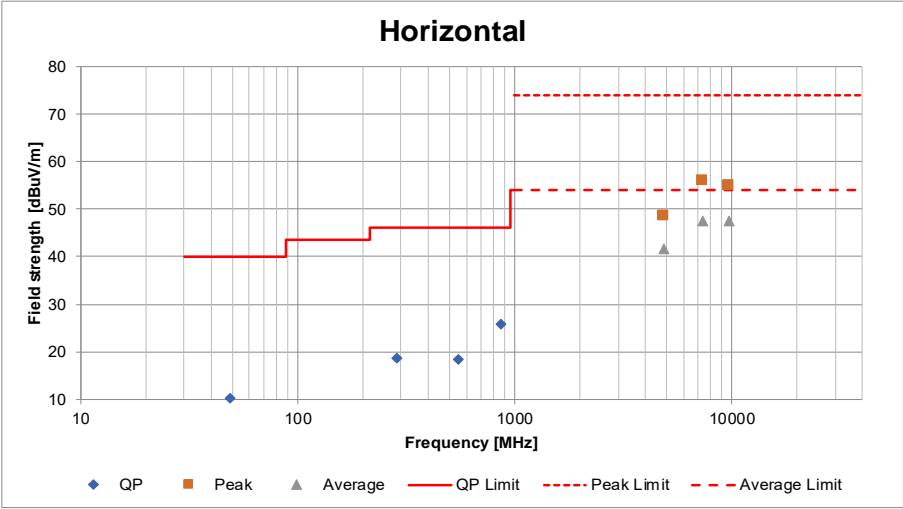
Ise EMC Lab.
 No.3
 April 14, 2024
 21 deg. C / 40 % RH
 Shousei Hamaguchi
 (1 GHz to 10 GHz)
 Tx, Hopping Off, 3DH5 2480 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
 Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission (Plot data, Worst case mode for Maximum Peak Output Power)

Test place	Ise EMC Lab.	No.3
Semi Anechoic Chamber	No.3	No.3
Date	April 14, 2024	April 15, 2024
Temperature / Humidity	21 deg. C / 40 % RH	20 deg. C / 51 % RH
Engineer	Shousei Hamaguchi (1 GHz to 10 GHz)	Tomoya Sone (Above 10 GHz and Below 1 GHz)
Mode	Tx, Hopping Off, 3DH5 2441 MHz	

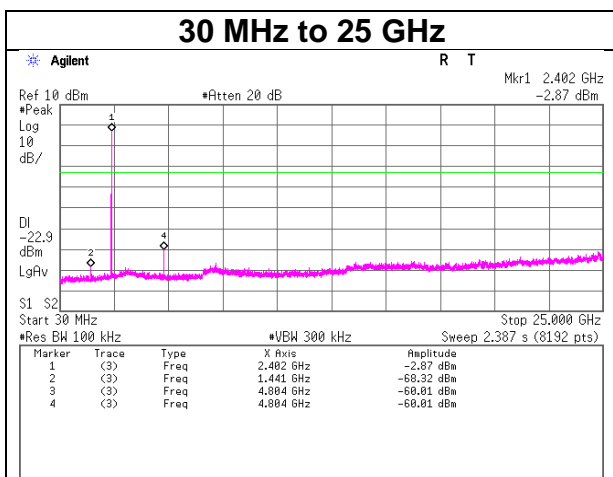
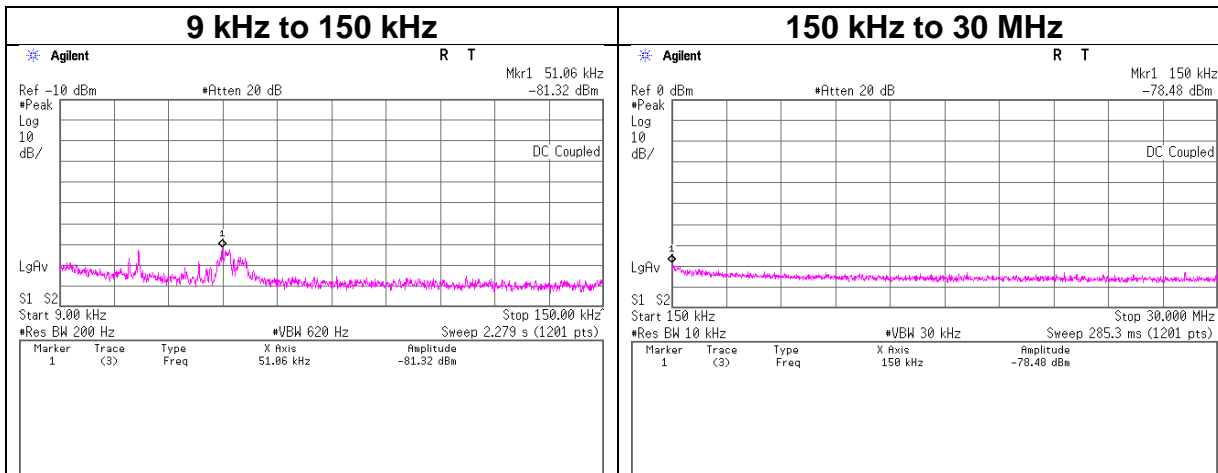


*These plots data contain sufficient number to show the trend of characteristic features for EUT.

Conducted Spurious Emission

Test place Ise EMC Lab. No.8 Measurement Room
Date April 3, 2024
Temperature / Humidity 23 deg. C / 47 % RH
Engineer Shousei Hamaguchi
Mode Tx, Hopping Off, DH5

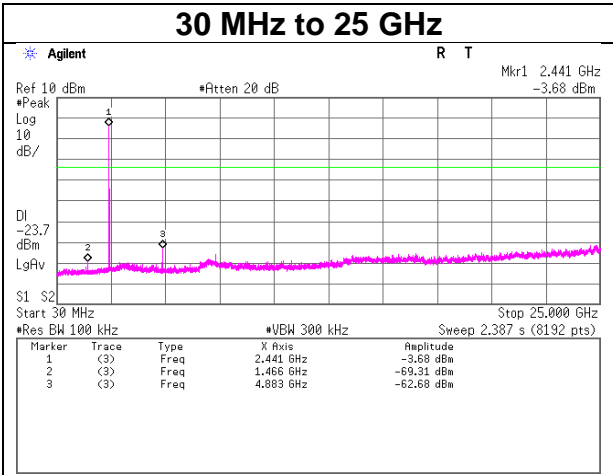
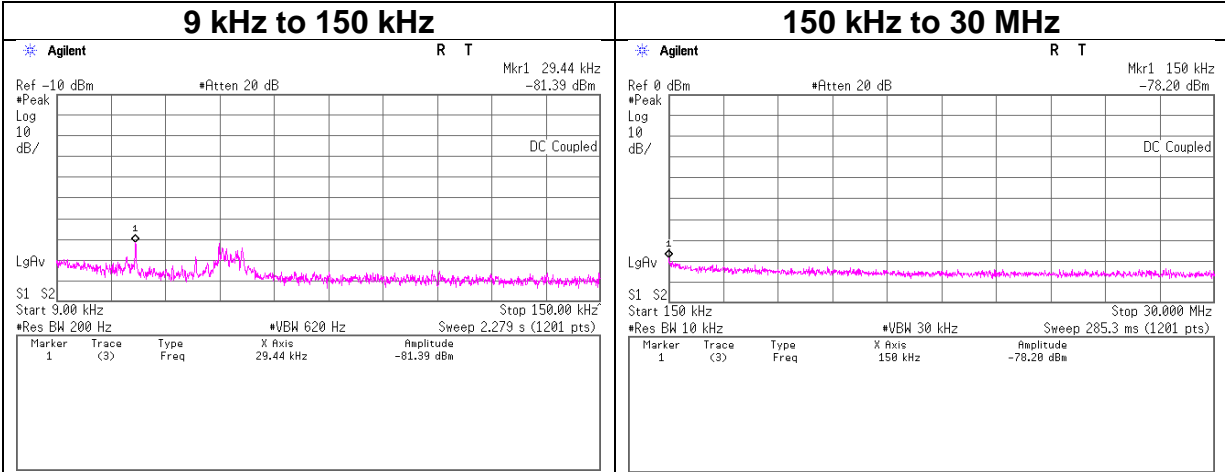
2402 MHz



Conducted Spurious Emission

Test place Ise EMC Lab. No.8 Measurement Room
 Date April 3, 2024
 Temperature / Humidity 23 deg. C / 47 % RH
 Engineer Shousei Hamaguchi
 Mode Tx, Hopping Off, DH5

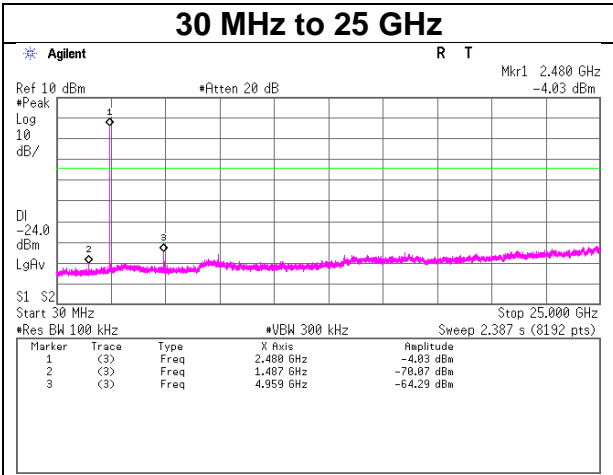
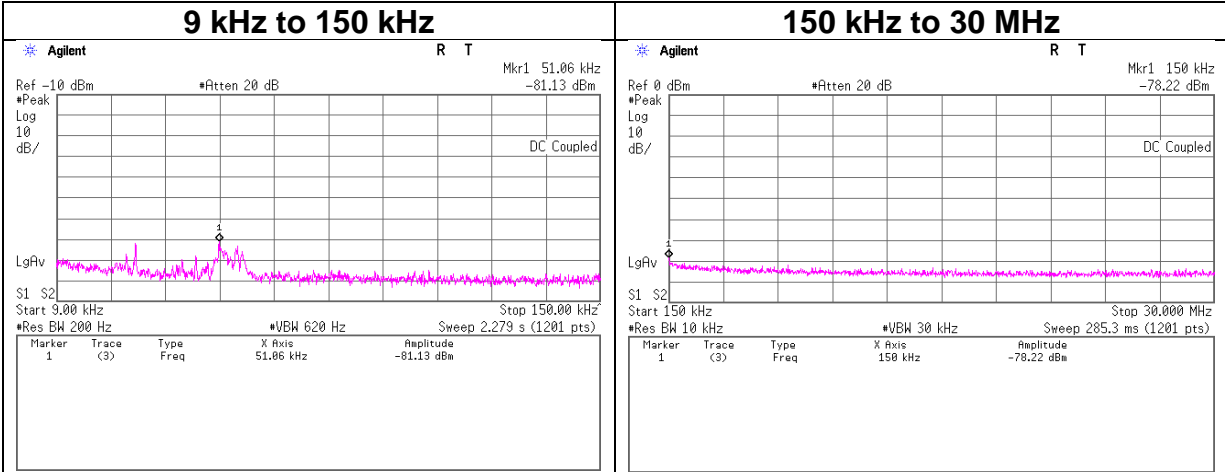
2441 MHz



Conducted Spurious Emission

Test place Ise EMC Lab. No.8 Measurement Room
 Date April 3, 2024
 Temperature / Humidity 23 deg. C / 47 % RH
 Engineer Shousei Hamaguchi
 Mode Tx, Hopping Off, DH5

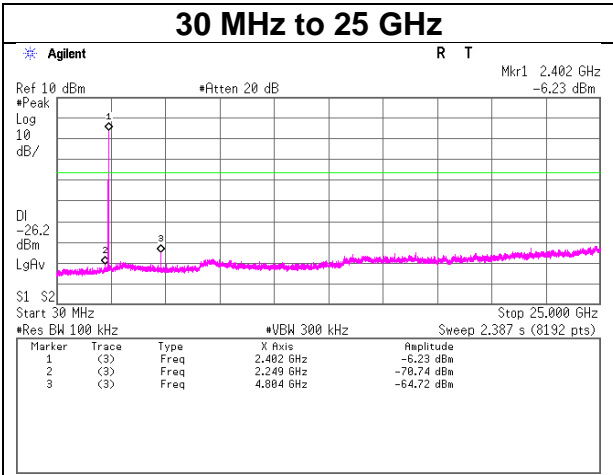
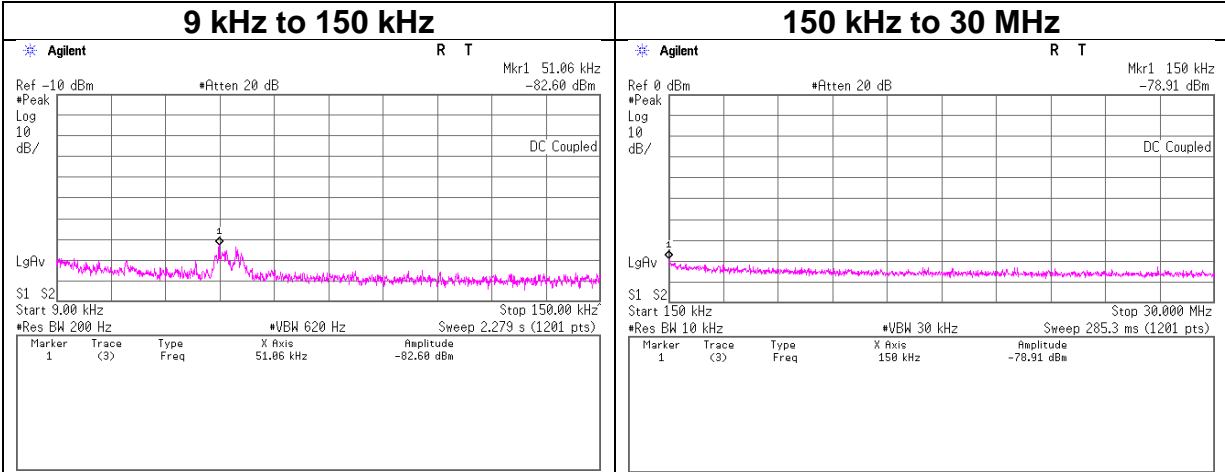
2480 MHz



Conducted Spurious Emission

Test place Ise EMC Lab. No.8 Measurement Room
 Date April 3, 2024
 Temperature / Humidity 23 deg. C / 47 % RH
 Engineer Shousei Hamaguchi
 Mode Tx, Hopping Off, 3DH5

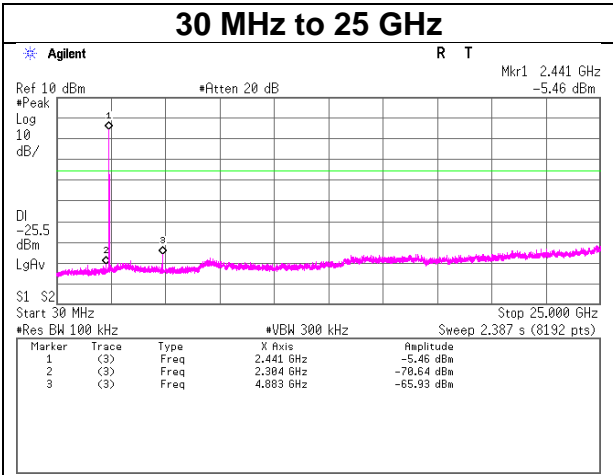
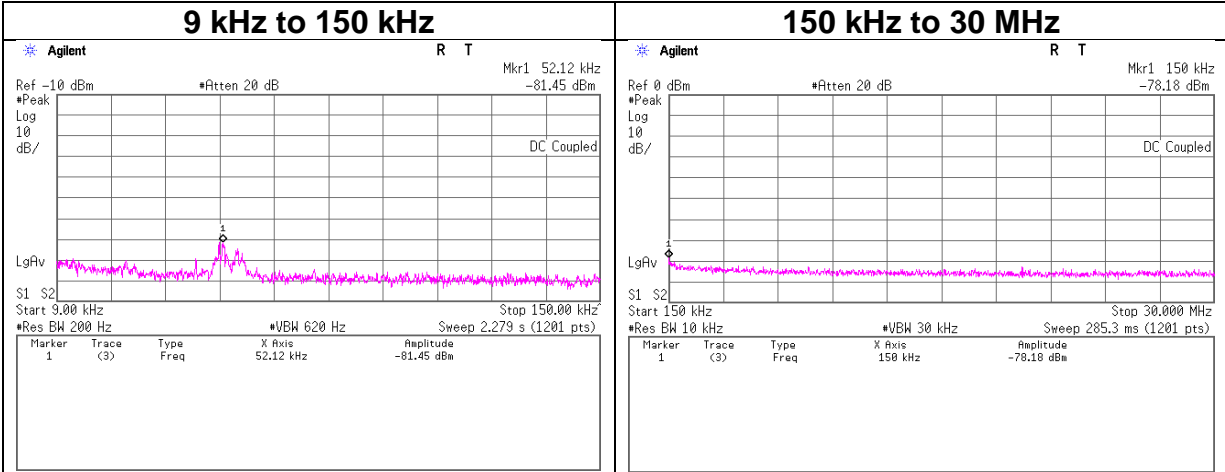
2402 MHz



Conducted Spurious Emission

Test place Ise EMC Lab. No.8 Measurement Room
 Date April 3, 2024
 Temperature / Humidity 23 deg. C / 47 % RH
 Engineer Shousei Hamaguchi
 Mode Tx, Hopping Off, 3DH5

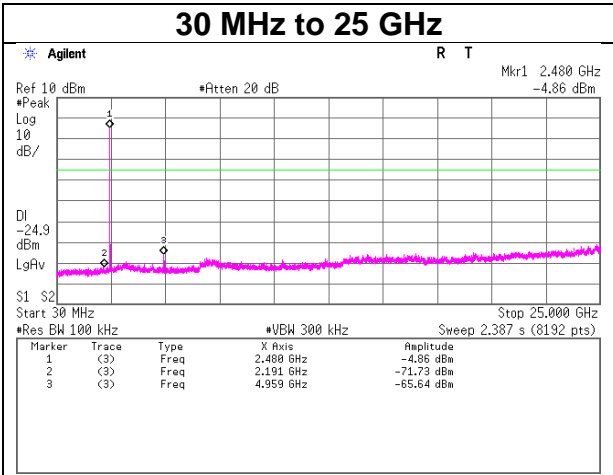
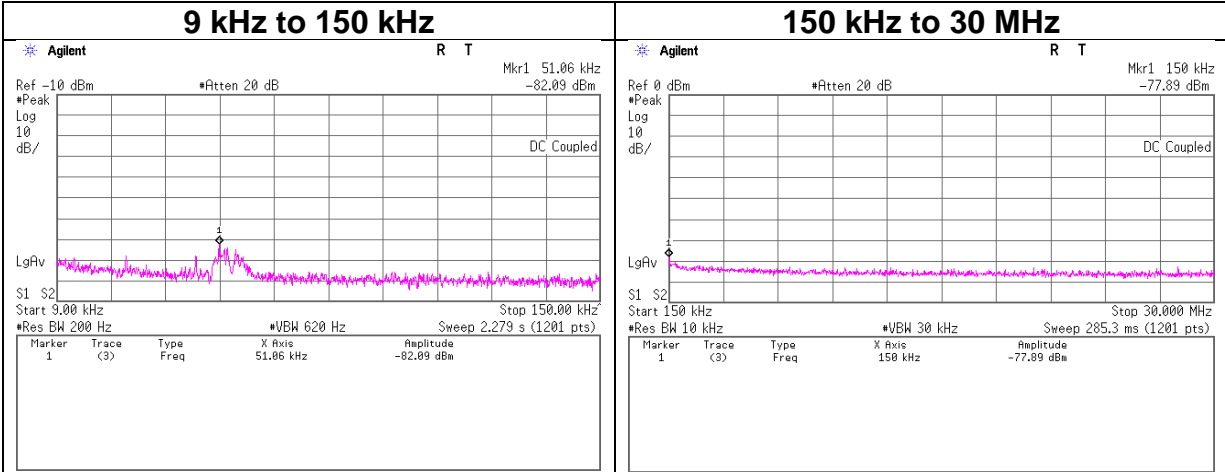
2441 MHz



Conducted Spurious Emission

Test place Ise EMC Lab. No.8 Measurement Room
 Date April 3, 2024
 Temperature / Humidity 23 deg. C / 47 % RH
 Engineer Shousei Hamaguchi
 Mode Tx, Hopping Off, 3DH5

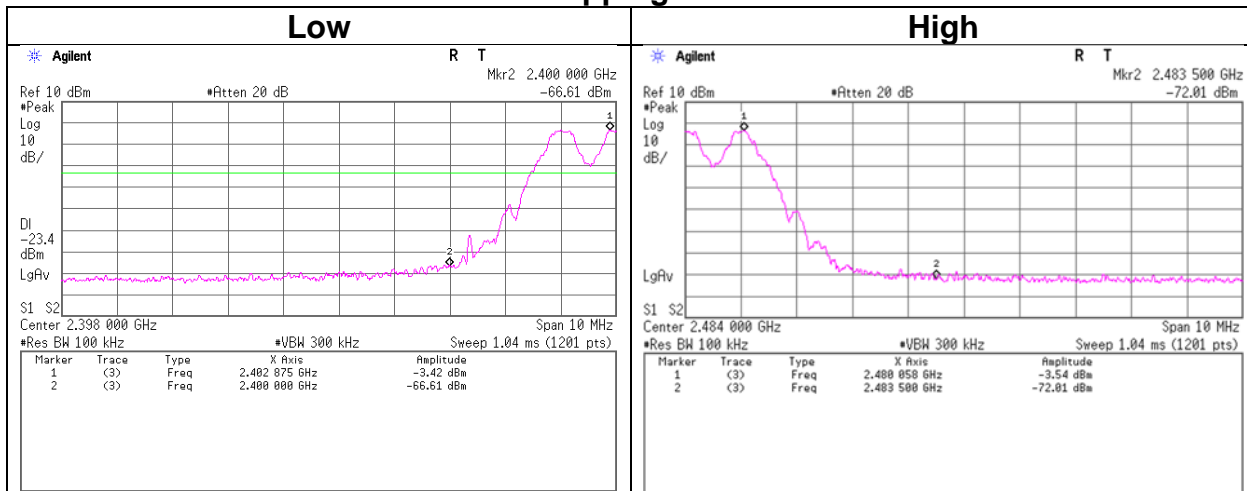
2480 MHz



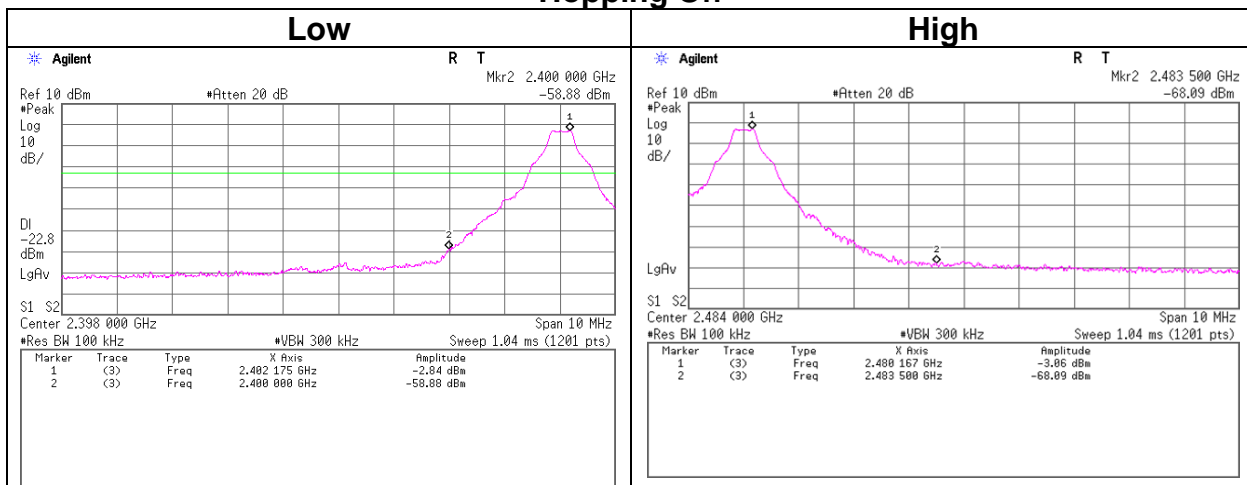
Conducted Emission Band Edge compliance

Test place Ise EMC Lab. No.8 Measurement Room
Date April 3, 2024
Temperature / Humidity 23 deg. C / 47 % RH
Engineer Shousei Hamaguchi
Mode Tx DH5

Hopping On



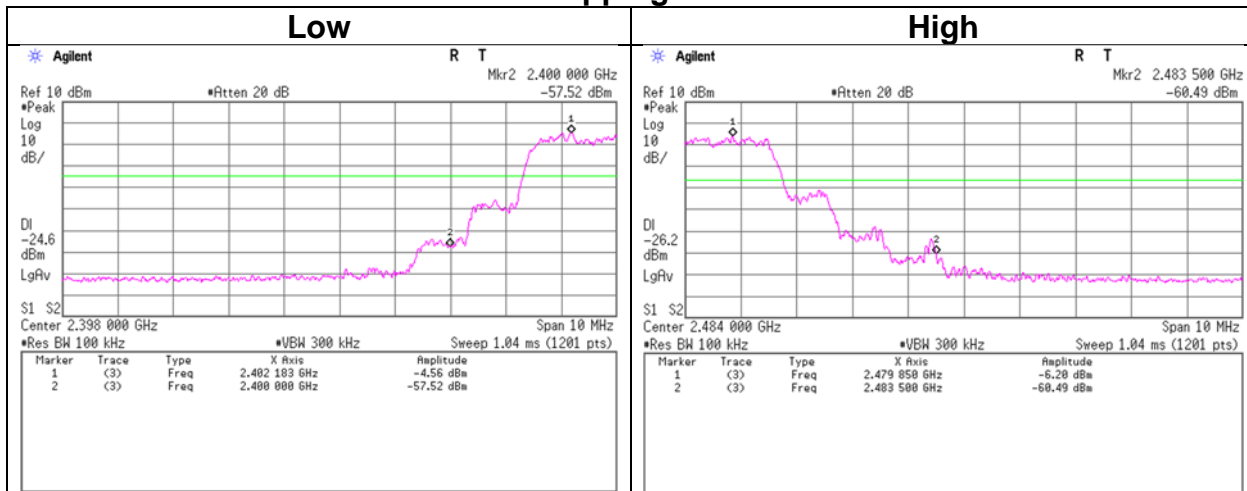
Hopping Off



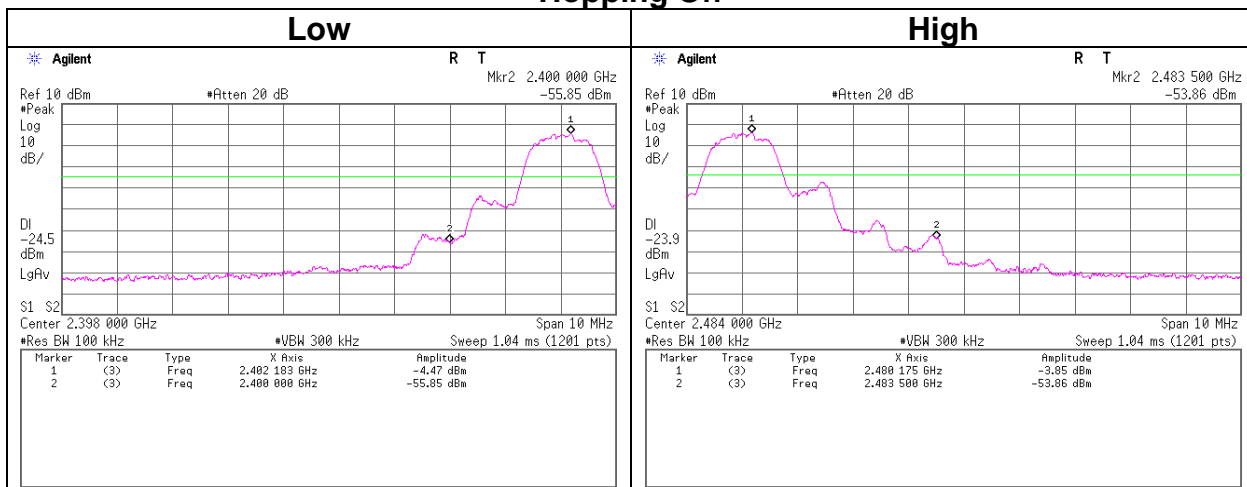
Conducted Emission Band Edge compliance

Test place Ise EMC Lab. No.8 Measurement Room
Date April 3, 2024
Temperature / Humidity 23 deg. C / 47 % RH
Engineer Shousei Hamaguchi
Mode Tx 3DH5

Hopping On



Hopping Off



APPENDIX 2: Test Instruments

Test Equipment

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
CE	141216	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W/SFM14/ suoform141-PE/ 421-010/ RFM-E321(SW)	-/00640	07/25/2023	12
CE	141290	Attenuator (13dB)	JFW Industries, Inc.	50FP-013H2 N	-	12/07/2023	12
CE	141357	LISN (AMN)	Schwarzbeck Mess-Elektronik OHG	NSLK8127	8127-729	07/05/2023	12
CE	141532	DIGITAL HiTESTER	HIOKI E.E. CORPORATION	3805	051201197	01/31/2024	12
CE	141554	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	1301	-	-
CE	141951	EMI Test Receiver	Rohde & Schwarz	ESR26	101408	04/10/2023	12
CE	142008	AC3_Semi Anechoic Chamber (NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	12/11/2023	24
CE	142183	Measure	KOMELON	KMC-36	-	10/20/2023	12
CE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	141232	High Pass Filter 3.5-18.0GHz	UL Japan	HPF SELECTOR	001	09/04/2023	12
RE	141266	Logperiodic Antenna (200-1000MHz)	Schwarzbeck Mess-Elektronik OHG	VUSLP9111B	9111B-191	08/10/2023	12
RE	141323	Coaxial cable	UL Japan	-	-	09/10/2023	12
RE	141424	Biconical Antenna	Schwarzbeck Mess-Elektronik OHG	VHA9103+ BBA9106	1915	03/15/2024	12
RE	141507	Horn Antenna 1-18GHz	Schwarzbeck Mess-Elektronik OHG	BBHA9120D	258	11/20/2023	12
RE	141513	Horn Antenna 15-40GHz	Schwarzbeck Mess-Elektronik OHG	BBHA9170	BBHA9170306	07/19/2023	12
RE	141532	DIGITAL HiTESTER	HIOKI E.E. CORPORATION	3805	051201197	01/31/2024	12
RE	141580	MicroWave System Amplifier	Keysight Technologies Inc	83017A	MY39500779	03/08/2024	12
RE	141582	Pre Amplifier	SONOMA INSTRUMENT	310	260834	02/17/2024	12
RE	141901	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY48250080	01/26/2024	12
RE	141950	EMI Test Receiver	Rohde & Schwarz	ESU26	100412	11/20/2023	12
RE	142008	AC3_Semi Anechoic Chamber (NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	12/11/2023	24
RE	142013	AC3_Semi Anechoic Chamber (SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	10/18/2023	12
RE	142183	Measure	KOMELON	KMC-36	-	10/20/2023	12
RE	142314	Attenuator	Pasternack Enterprises	PE7390-6	D/C 1504	06/23/2023	12
RE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	244709	Thermo-Hygrometer	HIOKI E.E. CORPORATION	LR5001	231202103	01/25/2024	12
RE	245787	Double Ridge Horn Antenna	Schwarzbeck Mess-Elektronik OHG	BBHA 9120 C	689	03/06/2024	12
RE	246001	Microwave Cable	Huber+Suhner	SF103/11PC35/ 11PC35/1000mm / SF126E/5000mm	800673(1m) / 610204(5m)	03/06/2024	12
AT	141244	Attenuator (10dB)	Weinschel - API Technologies Corp	WA8-10-34	A198	02/17/2024	12
AT	141327	Coaxial Cable	UL Japan	-	-	02/09/2024	12
AT	141420	Attenuator	Weinschel Associates	WA56-10	56100307	05/18/2023	12
AT	141557	DIGITAL HiTESTER	HIOKI E.E. CORPORATION	3805	070900530	01/31/2024	12
AT	141809	Power Meter	Anritsu Corporation	ML2495A	825002	05/26/2023	12
AT	141830	Power sensor	Anritsu Corporation	MA2411B	738285	05/26/2023	12
AT	141900	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY46185823	06/16/2023	12
AT	197220	Microwave cable	Huber+Suhner	SF126E/11PC35/ 11PC35/2000MM	537003/126E	03/14/2024	12
AT	244711	Thermo-Hygrometer	HIOKI E.E. CORPORATION	LR5001	231202105	01/25/2024	12

*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item:

AT: Antenna Terminal Conducted test

CE: Conducted Emission

RE: Radiated Emission